

# TMUX7236 44 V, Low-RON, 2:1 (SPDT), 2-Channel Precision Switch With Latch-Up Immunity and 1.8 V Logic

## 1 Features

- [Latch-up immune](#)
- Dual supply range:  $\pm 4.5$  V to  $\pm 22$  V
- Single supply range: 4.5 V to 44 V
- Low on-resistance: 2  $\Omega$
- High current support: 330 mA (maximum) (WQFN)
- $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  operating temperature
- [1.8 V logic compatible](#)
- [Integrated pull-down resistor on logic pins](#)
- [Fail-safe logic](#)
- [Rail-to-rail operation](#)
- [Bidirectional operation](#)

## 2 Applications

- [Gas meters](#)
- [Flow transmitters](#)
- [Factory automation and industrial controls](#)
- [Programmable logic controllers \(PLC\)](#)
- [Analog input modules](#)
- [Semiconductor test](#)
- [Data acquisition systems](#)
- [Ultrasound scanners](#)
- [Optical networking](#)
- [Optical test equipment](#)
- [Remote radio units](#)
- [Wired networking](#)
- [Patient monitoring and diagnostics](#)

## 3 Description

The TMUX7236 is a complementary metal-oxide semiconductor (CMOS) switch with latch-up immunity in a dual channel, 2:1 configuration. The device works well with dual supplies ( $\pm 5$  V to  $\pm 22$  V), a single supply (5 V to 44 V), or asymmetric supplies (such as  $V_{DD} = 12$  V,  $V_{SS} = -5$  V). The TMUX7236 supports bidirectional analog and digital signals on the source (Sx) and drain (D) pins ranging from  $V_{SS}$  to  $V_{DD}$ .

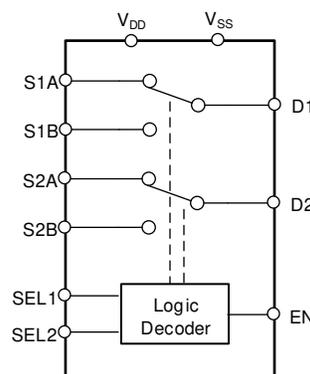
All logic control inputs support logic levels from 1.8 V to  $V_{DD}$ , ensuring both TTL and CMOS logic compatibility when operating in the valid supply voltage range. [Fail-Safe Logic](#) circuitry allows voltages on the control pins to be applied before the supply pin, protecting the device from potential damage.

The TMUX72xx family provides latch-up immunity, preventing undesirable high current events between parasitic structures within the device typically caused by overvoltage events. A latch-up condition typically continues until the power supply rails are turned off and can lead to device failure. The latch-up immunity feature allows the TMUX72xx family of switches and multiplexers to be used in harsh environments.

### Device Information<sup>(1)</sup>

DEVICE NUMBER	PACKAGE	BODY SIZE (NOM)
TMUX7236	WQFN (16)	4.00 mm $\times$ 4.00 mm

(1) For all available packages, see the package option addendum at the end of the data sheet.



**Block Diagram**



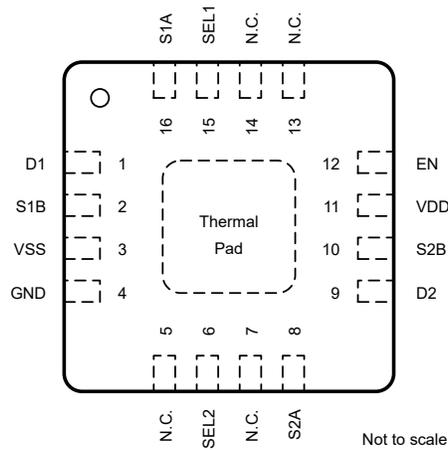
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## 4 Revision History

Changes from Revision * (March 2022) to Revision A (July 2022)	Page
• Changed the status of the data sheet from: <i>Advanced Information</i> to: <i>Production Data</i> .....	1

## 5 Pin Configuration and Functions



**Figure 5-1. RUM Package, 16-Pin WQFN (Top View)**

**Table 5-1. Pin Functions**

PIN		TYPE <sup>(1)</sup>	DESCRIPTION
NAME	NO.		
D1	1	I/O	Drain pin. Can be an input or output.
D2	9	I/O	Drain pin. Can be an input or output.
GND	4	P	Ground (0 V) reference
NC	5, 7, 13, 14	—	No internal connection. Can be shorted to GND or left floating.
S1A	16	I/O	Source pin 1A. Can be an input or output.
S1B	2	I/O	Source pin 1B. Can be an input or output.
S2A	8	I/O	Source pin 2A. Can be an input or output.
S2B	10	I/O	Source pin 2B. Can be an input or output.
EN	12	I	Active high logic enable, has internal pull-up resistor. When this pin is low, all switches are turned off. When this pin is high, the SEL logic input determine which switch is turned on.
SEL1	15	I	Logic control input, has internal pull-down resistor. Controls the switch connection as shown in <a href="#">Section 8.4</a> .
SEL2	6	I	Logic control input, has internal pull-down resistor. Controls the switch connection as shown in <a href="#">Section 8.4</a> .
V <sub>DD</sub>	11	P	Positive power supply. This pin is the most positive power-supply potential. For reliable operation, connect a decoupling capacitor ranging from 0.1 $\mu$ F to 10 $\mu$ F between V <sub>DD</sub> and GND.
V <sub>SS</sub>	3	P	Negative power supply. This pin is the most negative power-supply potential. In single-supply applications, this pin can be connected to ground. For reliable operation, connect a decoupling capacitor ranging from 0.1 $\mu$ F to 10 $\mu$ F between V <sub>SS</sub> and GND.
Thermal Pad		—	The thermal pad is not connected internally. There is no requirement to electrically connect this pad. If connected, however, it is recommended that the pad be left floating or tied to GND.

(1) I = input, O = output, P = power

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1) (2)</sup>

		MIN	MAX	UNIT
$V_{DD} - V_{SS}$	Supply voltage		48	V
$V_{DD}$		-0.5	48	V
$V_{SS}$		-48	0.5	V
$V_{SEL}$ or $V_{EN}$	Logic control input pin voltage (SELx)	-0.5	48	V
$I_{SEL}$ or $I_{EN}$	Logic control input pin current (SELx)	-30	30	mA
$V_S$ or $V_D$	Source or drain voltage (Sx, Dx)	$V_{SS}-0.5$	$V_{DD}+0.5$	V
$I_{IK}$	Diode clamp current <sup>(3)</sup>	-30	30	mA
$I_S$ or $I_D$ (CONT)	Source or drain continuous current (Sx, Dx)		$I_{DC} + 10\%$ <sup>(4)</sup>	mA
$T_A$	Ambient temperature	-55	150	°C
$T_{stg}$	Storage temperature	-65	150	°C
$T_J$	Junction temperature		150	°C
$P_{tot}$	Total power dissipation (QFN) <sup>(5)</sup>		1650	mW

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. *Absolute Maximum Ratings* do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) All voltages are with respect to ground, unless otherwise specified.
- (3) Pins are diode-clamped to the power-supply rails. Over voltage signals must be voltage and current limited to maximum ratings.
- (4) Refer to *Source or Drain Continuous Current* table for  $I_{DC}$  specifications.
- (5) For QFN package:  $P_{tot}$  derates linearly above  $T_A = 70^\circ\text{C}$  by  $24.2\text{mW}/^\circ\text{C}$ .

### 6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/ JEDEC JS-001, all pins <sup>(1)</sup>	$\pm 1000$	V
		Charged device model (CDM), per ANSI/ESDA/ JEDEC JS-002, all pins <sup>(2)</sup>	$\pm 500$	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Thermal Information

THERMAL METRIC <sup>(1)</sup>		TMUX7236	UNIT
		RUM (WQFN)	
		16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	41.5	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	25.1	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	16.5	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	0.3	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	16.4	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	2.9	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

### 6.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
$V_{DD} - V_{SS}$ <sup>(1)</sup>	Power supply voltage differential	4.5		44	V
$V_{DD}$	Positive power supply voltage	4.5		44	V
$V_S$ or $V_D$	Signal path input/output voltage (source or drain pin) (Sx, D)	$V_{SS}$		$V_{DD}$	V
$V_{SEL}$ or $V_{EN}$	Address or enable pin voltage	0		44	V
$I_S$ or $I_D (CONT)$	Source or drain continuous current (Sx, D)			$I_{DC}$ <sup>(2)</sup>	mA
$T_A$	Ambient temperature	-40		125	°C

(1)  $V_{DD}$  and  $V_{SS}$  can be any value as long as  $4.5\text{ V} \leq (V_{DD} - V_{SS}) \leq 44\text{ V}$ , and the minimum  $V_{DD}$  is met.

(2) Refer to *Source or Drain Continuous Current* table for  $I_{DC}$  specifications.

### 6.5 Source or Drain Continuous Current

at supply voltage of  $V_{DD} \pm 10\%$ ,  $V_{SS} \pm 10\%$  (unless otherwise noted)

CONTINUOUS CURRENT PER CHANNEL ( $I_{DC}$ ) <sup>(2)</sup>		$T_A = 25^\circ\text{C}$	$T_A = 85^\circ\text{C}$	$T_A = 125^\circ\text{C}$	UNIT
PACKAGE	TEST CONDITIONS				
RUM (WQFN)	+44 V Single Supply <sup>(1)</sup>	330	220	120	mA
	±15 V Dual Supply	330	220	120	mA
	+12 V Single Supply	260	180	110	mA
	±5 V Dual Supply	240	160	100	mA
	+5 V Single Supply	180	120	80	mA

(1) Specified for nominal supply voltage only.

(2) Refer to the total power dissipation ( $P_{tot}$ ) limits in the *Absolute Maximum Ratings* table, which must be followed with the maximum continuous current specification.

## 6.6 ±15 V Dual Supply: Electrical Characteristics

$V_{DD} = +15\text{ V} \pm 10\%$ ,  $V_{SS} = -15\text{ V} \pm 10\%$ , GND = 0 V (unless otherwise noted)

Typical at  $V_{DD} = +15\text{ V}$ ,  $V_{SS} = -15\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT	
<b>ANALOG SWITCH</b>								
$R_{ON}$	On-resistance	$V_S = -10\text{ V to } +10\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		2	2.7	$\Omega$	
			-40°C to +85°C			3.4	$\Omega$	
			-40°C to +125°C			4	$\Omega$	
$\Delta R_{ON}$	On-resistance mismatch between channels	$V_S = -10\text{ V to } +10\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		0.1	0.18	$\Omega$	
			-40°C to +85°C			0.19	$\Omega$	
			-40°C to +125°C			0.21	$\Omega$	
$R_{ON\ FLAT}$	On-resistance flatness	$V_S = -10\text{ V to } +10\text{ V}$ $I_S = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		0.2	0.46	$\Omega$	
			-40°C to +85°C			0.65	$\Omega$	
			-40°C to +125°C			0.7	$\Omega$	
$R_{ON\ DRIFT}$	On-resistance drift	$V_S = 0\text{ V}$ , $I_S = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	-40°C to +125°C		0.008		$\Omega/^\circ\text{C}$	
$I_{S(OFF)}$	Source off leakage current <sup>(1)</sup>	$V_{DD} = 16.5\text{ V}$ , $V_{SS} = -16.5\text{ V}$ Switch state is off $V_S = +10\text{ V} / -10\text{ V}$ $V_D = -10\text{ V} / +10\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-0.25	0.05	0.25	nA	
			-40°C to +85°C		-3		3	nA
			-40°C to +125°C		-20		20	nA
$I_{D(OFF)}$	Drain off leakage current <sup>(1)</sup>	$V_{DD} = 16.5\text{ V}$ , $V_{SS} = -16.5\text{ V}$ Switch state is off $V_S = +10\text{ V} / -10\text{ V}$ $V_D = -10\text{ V} / +10\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-0.6	0.1	0.6	nA	
			-40°C to +85°C		-7		7	nA
			-40°C to +125°C		-45		45	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current <sup>(2)</sup>	$V_{DD} = 16.5\text{ V}$ , $V_{SS} = -16.5\text{ V}$ Switch state is on $V_S = V_D = \pm 10\text{ V}$ Refer to <a href="#">On-Leakage Current</a>	25°C	-0.25	0.05	0.25	nA	
			-40°C to +85°C		-3		3	nA
			-40°C to +125°C		-20		20	nA
<b>LOGIC INPUTS (SEL / EN pins)</b>								
$V_{IH}$	Logic voltage high		-40°C to +125°C		1.3	44	V	
$V_{IL}$	Logic voltage low		-40°C to +125°C		0	0.8	V	
$I_{IH}$	Input leakage current		-40°C to +125°C		0.4	2	$\mu\text{A}$	
$I_{IL}$	Input leakage current		-40°C to +125°C	-1.5	-0.005		$\mu\text{A}$	
$C_{IN}$	Logic input capacitance		-40°C to +125°C		3.5		pF	
<b>POWER SUPPLY</b>								
$I_{DD}$	$V_{DD}$ supply current	$V_{DD} = 16.5\text{ V}$ , $V_{SS} = -16.5\text{ V}$ Logic inputs = 0 V, 5 V, or $V_{DD}$	25°C		35	56	$\mu\text{A}$	
			-40°C to +85°C			65	$\mu\text{A}$	
			-40°C to +125°C			80	$\mu\text{A}$	
$I_{SS}$	$V_{SS}$ supply current	$V_{DD} = 16.5\text{ V}$ , $V_{SS} = -16.5\text{ V}$ Logic inputs = 0 V, 5 V, or $V_{DD}$	25°C		5	20	$\mu\text{A}$	
			-40°C to +85°C			24	$\mu\text{A}$	
			-40°C to +125°C			35	$\mu\text{A}$	

(1) When  $V_S$  is positive,  $V_D$  is negative, or when  $V_S$  is negative,  $V_D$  is positive.

(2) When  $V_S$  is at a voltage potential,  $V_D$  is floating, or when  $V_D$  is at a voltage potential,  $V_S$  is floating.

## 6.7 ±15 V Dual Supply: Switching Characteristics

$V_{DD} = +15\text{ V} \pm 10\%$ ,  $V_{SS} = -15\text{ V} \pm 10\%$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

Typical at  $V_{DD} = +15\text{ V}$ ,  $V_{SS} = -15\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT
$t_{\text{TRAN}}$	Transition time from control input	$V_S = 10\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Transition Time</a>	25°C		110	125	ns
			-40°C to +85°C			140	ns
			-40°C to +125°C			155	ns
$t_{\text{ON}}$	Turn-on time from control input	$V_S = 10\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		95	120	ns
			-40°C to +85°C			135	ns
			-40°C to +125°C			145	ns
$t_{\text{OFF}}$	Turn-off time from control input	$V_S = 10\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		125	160	ns
			-40°C to +85°C			175	ns
			-40°C to +125°C			190	ns
$t_{\text{BBM}}$	Break-before-make time delay	$V_S = 10\text{ V}$ , $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Break-before-make Time</a>	25°C		27		ns
			-40°C to +85°C	5			ns
			-40°C to +125°C	5			ns
$t_{\text{ON}}(V_{DD})$	Device turn on time ( $V_{DD}$ to output)	$V_{DD}$ rise time = 1 $\mu\text{s}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on (VDD) Time</a>	25°C		0.17		ms
			-40°C to +85°C			0.18	ms
			-40°C to +125°C			0.18	ms
$t_{\text{PD}}$	Propagation delay	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ Refer to <a href="#">Propagation Delay</a>	25°C		720		ps
$Q_{\text{INJ}}$	Charge injection	$V_S = 0\text{ V}$ , $C_L = 100\text{ pF}$ Refer to <a href="#">Charge Injection</a>	25°C		30		pC
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-70		dB
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-50		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-107		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-93		dB
BW	-3 dB Bandwidth	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ Refer to <a href="#">Bandwidth</a>	25°C		40		MHz
$I_L$	Insertion loss	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		-0.15		dB
ACPSRR	AC Power Supply Rejection Ratio	$V_{PP} = 0.62\text{ V}$ on $V_{DD}$ and $V_{SS}$ $R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 1\text{ MHz}$ Refer to <a href="#">ACPSRR</a>	25°C		-68		dB
THD+N	Total Harmonic Distortion + Noise	$V_{PP} = 15\text{ V}$ , $V_{BIAS} = 0\text{ V}$ $R_L = 10\text{ k}\Omega$ , $C_L = 5\text{ pF}$ , $f = 20\text{ Hz}$ to $20\text{ kHz}$ Refer to <a href="#">THD + Noise</a>	25°C		0.0006		%
$C_{S(\text{OFF})}$	Source off capacitance	$V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		45		pF
$C_{D(\text{OFF})}$	Drain off capacitance	$V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		55		pF
$C_{S(\text{ON})}$ , $C_{D(\text{ON})}$	On capacitance	$V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		165		pF

## 6.8 ±20 V Dual Supply: Electrical Characteristics

$V_{DD} = +20\text{ V} \pm 10\%$ ,  $V_{SS} = -20\text{ V} \pm 10\%$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

Typical at  $V_{DD} = +20\text{ V}$ ,  $V_{SS} = -20\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT
<b>ANALOG SWITCH</b>							
$R_{ON}$	On-resistance	$V_S = -15\text{ V to }+15\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		1.7	2.5	$\Omega$
			-40°C to +85°C			3.2	$\Omega$
			-40°C to +125°C			3.8	$\Omega$
$\Delta R_{ON}$	On-resistance mismatch between channels	$V_S = -15\text{ V to }+15\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		0.1	0.18	$\Omega$
			-40°C to +85°C			0.19	$\Omega$
			-40°C to +125°C			0.21	$\Omega$
$R_{ON\text{ FLAT}}$	On-resistance flatness	$V_S = -15\text{ V to }+15\text{ V}$ $I_S = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		0.3	0.6	$\Omega$
			-40°C to +85°C			0.8	$\Omega$
			-40°C to +125°C			0.95	$\Omega$
$R_{ON\text{ DRIFT}}$	On-resistance drift	$V_S = 0\text{ V}$ , $I_S = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	-40°C to +125°C		0.008		$\Omega/^\circ\text{C}$
$I_{S(OFF)}$	Source off leakage current <sup>(1)</sup>	$V_{DD} = 22\text{ V}$ , $V_{SS} = -22\text{ V}$ Switch state is off $V_S = +15\text{ V} / -15\text{ V}$ $V_D = -15\text{ V} / +15\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-1	0.05	1	nA
			-40°C to +85°C		-4.5	4.5	nA
			-40°C to +125°C		-33	33	nA
$I_{D(OFF)}$	Drain off leakage current <sup>(1)</sup>	$V_{DD} = 22\text{ V}$ , $V_{SS} = -22\text{ V}$ Switch state is off $V_S = +15\text{ V} / -15\text{ V}$ $V_D = -15\text{ V} / +15\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-2.2	0.22	2.2	nA
			-40°C to +85°C		-10	10	nA
			-40°C to +125°C		-70	70	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current <sup>(2)</sup>	$V_{DD} = 22\text{ V}$ , $V_{SS} = -22\text{ V}$ Switch state is on $V_S = V_D = \pm 15\text{ V}$ Refer to <a href="#">On-Leakage Current</a>	25°C	-1	0.05	1	nA
			-40°C to +85°C		-4.5	4.5	nA
			-40°C to +125°C		-33	33	nA
<b>LOGIC INPUTS (SEL / EN pins)</b>							
$V_{IH}$	Logic voltage high		-40°C to +125°C	1.3		44	V
$V_{IL}$	Logic voltage low		-40°C to +125°C	0		0.8	V
$I_{IH}$	Input leakage current		-40°C to +125°C		0.4	2	$\mu\text{A}$
$I_{IL}$	Input leakage current		-40°C to +125°C	-1.2	-0.005		$\mu\text{A}$
$C_{IN}$	Logic input capacitance		-40°C to +125°C		3.5		pF
<b>POWER SUPPLY</b>							
$I_{DD}$	$V_{DD}$ supply current	$V_{DD} = 22\text{ V}$ , $V_{SS} = -22\text{ V}$ Logic inputs = 0 V, 5 V, or $V_{DD}$	25°C		33	65	$\mu\text{A}$
			-40°C to +85°C			74	$\mu\text{A}$
			-40°C to +125°C			90	$\mu\text{A}$
$I_{SS}$	$V_{SS}$ supply current	$V_{DD} = 22\text{ V}$ , $V_{SS} = -22\text{ V}$ Logic inputs = 0 V, 5 V, or $V_{DD}$	25°C		7	26	$\mu\text{A}$
			-40°C to +85°C			30	$\mu\text{A}$
			-40°C to +125°C			45	$\mu\text{A}$

(1) When  $V_S$  is positive,  $V_D$  is negative, or when  $V_S$  is negative,  $V_D$  is positive.

(2) When  $V_S$  is at a voltage potential,  $V_D$  is floating, or when  $V_D$  is at a voltage potential,  $V_S$  is floating.

## 6.9 ±20 V Dual Supply: Switching Characteristics

$V_{DD} = +20\text{ V} \pm 10\%$ ,  $V_{SS} = -20\text{ V} \pm 10\%$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

Typical at  $V_{DD} = +20\text{ V}$ ,  $V_{SS} = -20\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT
$t_{\text{TRAN}}$	Transition time from control input	$V_S = 10\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Transition Time</a>	25°C		100	160	ns
			-40°C to +85°C			170	ns
			-40°C to +125°C			180	ns
$t_{\text{ON}}$	Turn-on time from control input	$V_S = 10\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		95	140	ns
			-40°C to +85°C			160	ns
			-40°C to +125°C			180	ns
$t_{\text{OFF}}$	Turn-off time from control input	$V_S = 10\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		125	150	ns
			-40°C to +85°C			165	ns
			-40°C to +125°C			190	ns
$t_{\text{BBM}}$	Break-before-make time delay	$V_S = 10\text{ V}$ , $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Break-before-make Time</a>	25°C		28		ns
			-40°C to +85°C	5			ns
			-40°C to +125°C	5			ns
$t_{\text{ON (VDD)}}$	Device turn on time ( $V_{DD}$ to output)	$V_{DD}$ rise time = 1 $\mu\text{s}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on (VDD) Time</a>	25°C		0.17		ms
			-40°C to +85°C			0.18	ms
			-40°C to +125°C			0.18	ms
$t_{\text{PD}}$	Propagation delay	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ Refer to <a href="#">Propagation Delay</a>	25°C		740		ps
$Q_{\text{INJ}}$	Charge injection	$V_S = 0\text{ V}$ , $C_L = 100\text{ pF}$ Refer to <a href="#">Charge Injection</a>	25°C		45		pC
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-70		dB
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-50		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-107		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-93		dB
BW	-3 dB Bandwidth	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ Refer to <a href="#">Bandwidth</a>	25°C		35		MHz
$I_L$	Insertion loss	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		-0.14		dB
ACPSRR	AC Power Supply Rejection Ratio	$V_{PP} = 0.62\text{ V}$ on $V_{DD}$ and $V_{SS}$ $R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 1\text{ MHz}$ Refer to <a href="#">ACPSRR</a>	25°C		-68		dB
THD+N	Total Harmonic Distortion + Noise	$V_{PP} = 20\text{ V}$ , $V_{BIAS} = 0\text{ V}$ $R_L = 10\text{ k}\Omega$ , $C_L = 5\text{ pF}$ , $f = 20\text{ Hz}$ to $20\text{ kHz}$ Refer to <a href="#">THD + Noise</a>	25°C		0.0006		%
$C_{S(\text{OFF})}$	Source off capacitance	$V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		45		pF
$C_{D(\text{OFF})}$	Drain off capacitance	$V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		55		pF
$C_{S(\text{ON})}$ , $C_{D(\text{ON})}$	On capacitance	$V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	25°C		165		pF

## 6.10 44 V Single Supply: Electrical Characteristics

$V_{DD} = +44\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

Typical at  $V_{DD} = +44\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT	
<b>ANALOG SWITCH</b>								
$R_{ON}$	On-resistance	$V_S = 0\text{ V to }40\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		2	2.4	$\Omega$	
			-40°C to +85°C			3.2	$\Omega$	
			-40°C to +125°C			3.8	$\Omega$	
$\Delta R_{ON}$	On-resistance mismatch between channels	$V_S = 0\text{ V to }40\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		0.1	0.18	$\Omega$	
			-40°C to +85°C			0.19	$\Omega$	
			-40°C to +125°C			0.21	$\Omega$	
$R_{ON\text{ FLAT}}$	On-resistance flatness	$V_S = 0\text{ V to }40\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		0.65	0.8	$\Omega$	
			-40°C to +85°C			1.1	$\Omega$	
			-40°C to +125°C			1.2	$\Omega$	
$R_{ON\text{ DRIFT}}$	On-resistance drift	$V_S = 22\text{ V}$ , $I_S = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	-40°C to +125°C		0.007		$\Omega/^\circ\text{C}$	
$I_{S(OFF)}$	Source off leakage current <sup>(1)</sup>	$V_{DD} = 44\text{ V}$ , $V_{SS} = 0\text{ V}$ Switch state is off $V_S = 40\text{ V} / 1\text{ V}$ $V_D = 1\text{ V} / 40\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-1	0.05	1	nA	
			-40°C to +85°C		-7		7	nA
			-40°C to +125°C		-50		50	nA
$I_{D(OFF)}$	Drain off leakage current <sup>(1)</sup>	$V_{DD} = 44\text{ V}$ , $V_{SS} = 0\text{ V}$ Switch state is off $V_S = 40\text{ V} / 1\text{ V}$ $V_D = 1\text{ V} / 40\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-2.2	0.12	2.2	nA	
			-40°C to +85°C		-15		15	nA
			-40°C to +125°C		-115		115	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current <sup>(2)</sup>	$V_{DD} = 44\text{ V}$ , $V_{SS} = 0\text{ V}$ Switch state is on $V_S = V_D = 40\text{ V or }1\text{ V}$ Refer to <a href="#">On-Leakage Current</a>	25°C	-1	0.05	1	nA	
			-40°C to +85°C		-7		7	nA
			-40°C to +125°C		-50		50	nA
<b>LOGIC INPUTS (SEL / EN pins)</b>								
$V_{IH}$	Logic voltage high		-40°C to +125°C		1.3	44	V	
$V_{IL}$	Logic voltage low		-40°C to +125°C		0	0.8	V	
$I_{IH}$	Input leakage current		-40°C to +125°C		1	2.75	$\mu\text{A}$	
$I_{IL}$	Input leakage current		-40°C to +125°C	-1.2	-0.005		$\mu\text{A}$	
$C_{IN}$	Logic input capacitance		-40°C to +125°C		3.5		pF	
<b>POWER SUPPLY</b>								
$I_{DD}$	$V_{DD}$ supply current	$V_{DD} = 44\text{ V}$ , $V_{SS} = 0\text{ V}$ Logic inputs = 0 V, 5 V, or $V_{DD}$	25°C		44	79	$\mu\text{A}$	
			-40°C to +85°C			88	$\mu\text{A}$	
			-40°C to +125°C			105	$\mu\text{A}$	

(1) When  $V_S$  is positive,  $V_D$  is negative, or when  $V_S$  is negative,  $V_D$  is positive.

(2) When  $V_S$  is at a voltage potential,  $V_D$  is floating, or when  $V_D$  is at a voltage potential,  $V_S$  is floating.

## 6.11 44 V Single Supply: Switching Characteristics

$V_{DD} = +44\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

Typical at  $V_{DD} = +44\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT
$t_{\text{TRAN}}$	Transition time from control input	$V_S = 18\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Transition Time</a>	25°C		85	145	ns
			-40°C to +85°C			155	ns
			-40°C to +125°C			185	ns
$t_{\text{ON}}$	Turn-on time from control input	$V_S = 18\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		90	130	ns
			-40°C to +85°C			140	ns
			-40°C to +125°C			160	ns
$t_{\text{OFF}}$	Turn-off time from control input	$V_S = 18\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		125	160	ns
			-40°C to +85°C			170	ns
			-40°C to +125°C			180	ns
$t_{\text{BBM}}$	Break-before-make time delay	$V_S = 18\text{ V}$ , $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Break-before-make Time</a>	25°C		27		ns
			-40°C to +85°C		10		ns
			-40°C to +125°C		10		ns
$t_{\text{ON}}(V_{DD})$	Device turn on time ( $V_{DD}$ to output)	$V_{DD}$ rise time = 1 $\mu\text{s}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on (VDD) Time</a>	25°C		0.14		ms
			-40°C to +85°C			0.15	ms
			-40°C to +125°C			0.15	ms
$t_{\text{PD}}$	Propagation delay	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ Refer to <a href="#">Propagation Delay</a>	25°C		900		ps
$Q_{\text{INJ}}$	Charge injection	$V_S = 22\text{ V}$ , $C_L = 100\text{ pF}$ Refer to <a href="#">Charge Injection</a>	25°C		104		pC
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-70		dB
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-50		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-112		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-93		dB
BW	-3 dB Bandwidth	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ Refer to <a href="#">Bandwidth</a>	25°C		35		MHz
$I_L$	Insertion loss	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 1\text{ MHz}$	25°C		-0.15		dB
ACPSRR	AC Power Supply Rejection Ratio	$V_{PP} = 0.62\text{ V}$ on $V_{DD}$ and $V_{SS}$ $R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 1\text{ MHz}$ Refer to <a href="#">ACPSRR</a>	25°C		-66		dB
THD+N	Total Harmonic Distortion + Noise	$V_{PP} = 22\text{ V}$ , $V_{BIAS} = 22\text{ V}$ $R_L = 10\text{ k}\Omega$ , $C_L = 5\text{ pF}$ , $f = 20\text{ Hz}$ to $20\text{ kHz}$ Refer to <a href="#">THD + Noise</a>	25°C		0.0006		%
$C_{S(\text{OFF})}$	Source off capacitance	$V_S = 22\text{ V}$ , $f = 1\text{ MHz}$	25°C		45		pF
$C_{D(\text{OFF})}$	Drain off capacitance	$V_S = 22\text{ V}$ , $f = 1\text{ MHz}$	25°C		55		pF
$C_{S(\text{ON})}$ , $C_{D(\text{ON})}$	On capacitance	$V_S = 22\text{ V}$ , $f = 1\text{ MHz}$	25°C		165		pF

## 6.12 12 V Single Supply: Electrical Characteristics

$V_{DD} = +12\text{ V} \pm 10\%$ ,  $V_{SS} = 0\text{ V}$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

Typical at  $V_{DD} = +12\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT	
<b>ANALOG SWITCH</b>								
$R_{ON}$	On-resistance	$V_S = 0\text{ V to }10\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C	2.8	5.4		$\Omega$	
			-40°C to +85°C			6.8	$\Omega$	
			-40°C to +125°C			7.4	$\Omega$	
$\Delta R_{ON}$	On-resistance mismatch between channels	$V_S = 0\text{ V to }10\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C	0.13	0.21		$\Omega$	
			-40°C to +85°C			0.23	$\Omega$	
			-40°C to +125°C			0.25	$\Omega$	
$R_{ON\text{ FLAT}}$	On-resistance flatness	$V_S = 0\text{ V to }10\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C	0.8	1.7		$\Omega$	
			-40°C to +85°C			1.9	$\Omega$	
			-40°C to +125°C			2	$\Omega$	
$R_{ON\text{ DRIFT}}$	On-resistance drift	$V_S = 6\text{ V}$ , $I_S = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	-40°C to +125°C	0.015			$\Omega/^\circ\text{C}$	
$I_{S(OFF)}$	Source off leakage current <sup>(1)</sup>	$V_{DD} = 13.2\text{ V}$ , $V_{SS} = 0\text{ V}$ Switch state is off $V_S = 10\text{ V} / 1\text{ V}$ $V_D = 1\text{ V} / 10\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-0.25	0.01	0.25	nA	
			-40°C to +85°C		-2		2	nA
			-40°C to +125°C		-16		16	nA
$I_{D(OFF)}$	Drain off leakage current <sup>(1)</sup>	$V_{DD} = 13.2\text{ V}$ , $V_{SS} = 0\text{ V}$ Switch state is off $V_S = 10\text{ V} / 1\text{ V}$ $V_D = 1\text{ V} / 10\text{ V}$ Refer to <a href="#">Off-Leakage Current</a>	25°C	-0.6	0.12	0.6	nA	
			-40°C to +85°C		-5		5	nA
			-40°C to +125°C		-34		34	nA
$I_{S(ON)}$ $I_{D(ON)}$	Channel on leakage current <sup>(2)</sup>	$V_{DD} = 13.2\text{ V}$ , $V_{SS} = 0\text{ V}$ Switch state is on $V_S = V_D = 10\text{ V or }1\text{ V}$ Refer to <a href="#">On-Leakage Current</a>	25°C	-0.25	0.01	0.25	nA	
			-40°C to +85°C		-2		2	nA
			-40°C to +125°C		-16		16	nA
<b>LOGIC INPUTS (SEL / EN pins)</b>								
$V_{IH}$	Logic voltage high		-40°C to +125°C	1.3		44	V	
$V_{IL}$	Logic voltage low		-40°C to +125°C	0		0.8	V	
$I_{IH}$	Input leakage current		-40°C to +125°C		0.4	2.25	$\mu\text{A}$	
$I_{IL}$	Input leakage current		-40°C to +125°C	-1.25	-0.005		$\mu\text{A}$	
$C_{IN}$	Logic input capacitance		-40°C to +125°C		3.5		pF	
<b>POWER SUPPLY</b>								
$I_{DD}$	$V_{DD}$ supply current	$V_{DD} = 13.2\text{ V}$ , $V_{SS} = 0\text{ V}$ Logic inputs = 0 V, 5 V, or $V_{DD}$	25°C	30	44		$\mu\text{A}$	
			-40°C to +85°C			52	$\mu\text{A}$	
			-40°C to +125°C			62	$\mu\text{A}$	

(1) When  $V_S$  is positive,  $V_D$  is negative, or when  $V_S$  is negative,  $V_D$  is positive.

(2) When  $V_S$  is at a voltage potential,  $V_D$  is floating, or when  $V_D$  is at a voltage potential,  $V_S$  is floating.

### 6.13 12 V Single Supply: Switching Characteristics

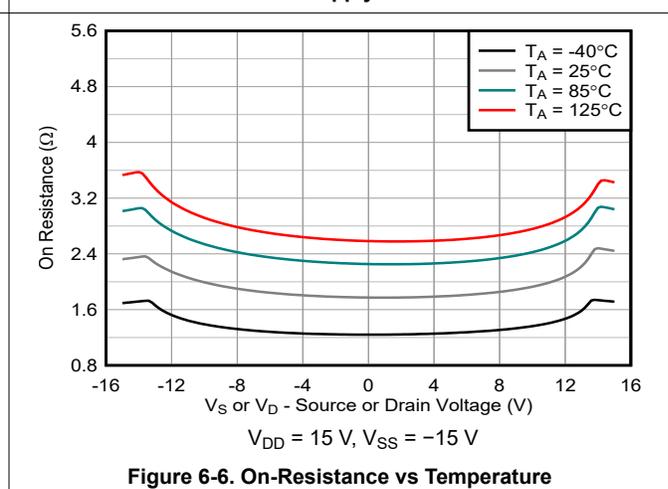
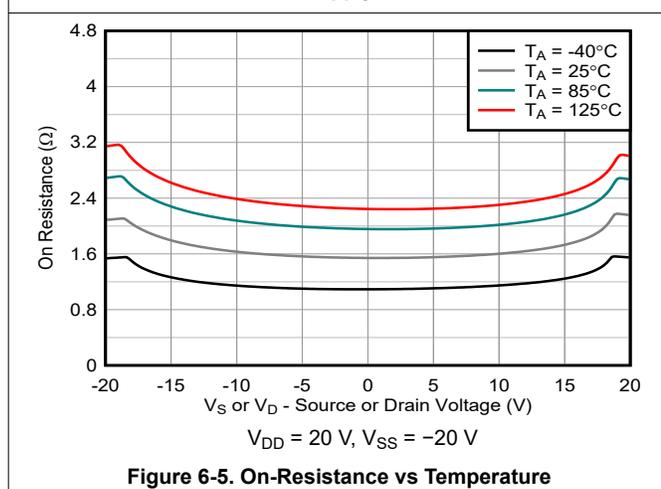
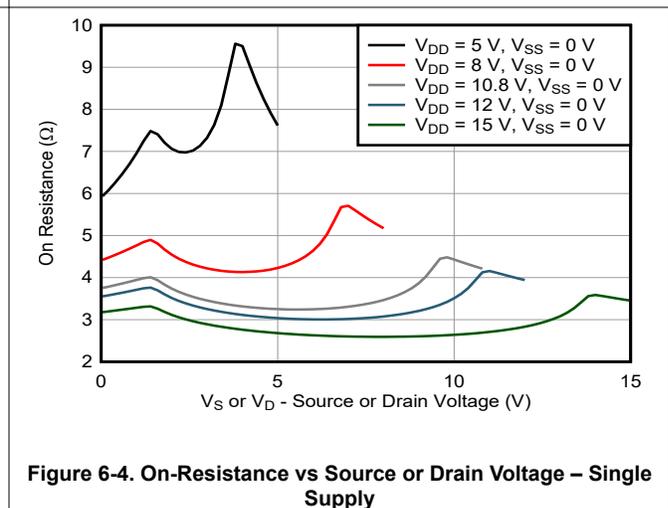
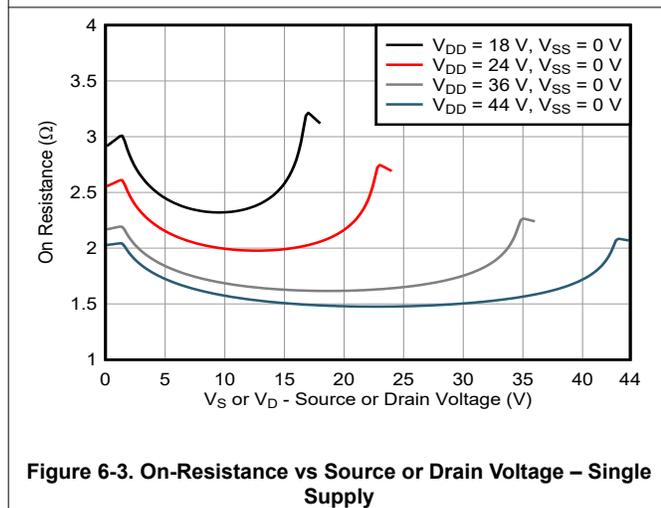
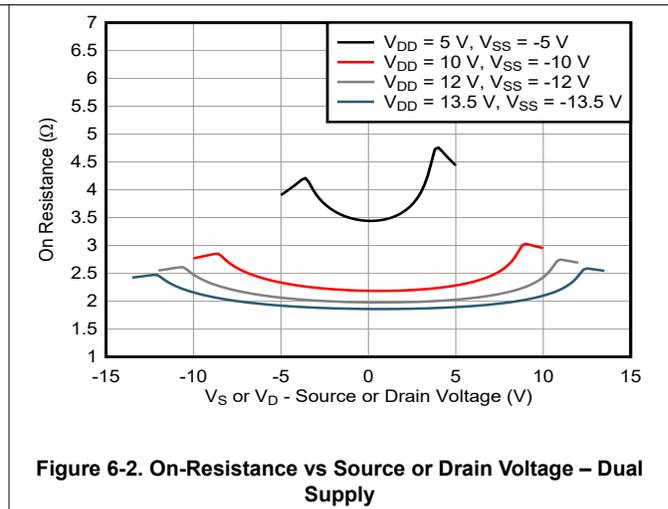
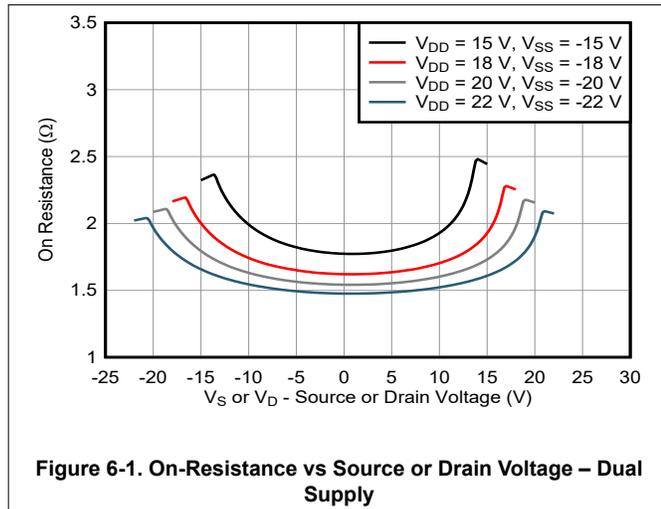
 $V_{DD} = +12\text{ V} \pm 10\%$ ,  $V_{SS} = 0\text{ V}$ ,  $GND = 0\text{ V}$  (unless otherwise noted)

 Typical at  $V_{DD} = +12\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT
$t_{\text{TRAN}}$	Transition time from control input	$V_S = 8\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Transition Time</a>	25°C		90	160	ns
			-40°C to +85°C			190	ns
			-40°C to +125°C			225	ns
$t_{\text{ON}}$	Turn-on time from control input	$V_S = 8\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		190	235	ns
			-40°C to +85°C			260	ns
			-40°C to +125°C			280	ns
$t_{\text{OFF}}$	Turn-off time from control input	$V_S = 8\text{ V}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on and Turn-off Time</a>	25°C		160	200	ns
			-40°C to +85°C			220	ns
			-40°C to +125°C			245	ns
$t_{\text{BBM}}$	Break-before-make time delay	$V_S = 8\text{ V}$ , $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Break-before-make Time</a>	25°C		30		ns
			-40°C to +85°C	9			ns
			-40°C to +125°C	9			ns
$t_{\text{ON}}(\text{VDD})$	Device turn on time ( $V_{DD}$ to output)	$V_{DD}$ rise time = 1 $\mu\text{s}$ $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ Refer to <a href="#">Turn-on (VDD) Time</a>	25°C		0.17		ms
			-40°C to +85°C			0.18	ms
			-40°C to +125°C			0.18	ms
$t_{\text{PD}}$	Propagation delay	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ Refer to <a href="#">Propagation Delay</a>	25°C		770		ps
$Q_{\text{INJ}}$	Charge injection	$V_S = 6\text{ V}$ , $C_L = 100\text{ pF}$ Refer to <a href="#">Charge Injection</a>	25°C		12		pC
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-70		dB
$O_{\text{ISO}}$	Off-isolation	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Off Isolation</a>	25°C		-50		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 100\text{ kHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-112		dB
$X_{\text{TALK}}$	Crosstalk	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 1\text{ MHz}$ Refer to <a href="#">Crosstalk</a>	25°C		-93		dB
BW	-3 dB Bandwidth	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ Refer to <a href="#">Bandwidth</a>	25°C		50		MHz
$I_L$	Insertion loss	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ $V_S = 6\text{ V}$ , $f = 1\text{ MHz}$	25°C		-0.25		dB
ACPSRR	AC Power Supply Rejection Ratio	$V_{\text{PP}} = 0.62\text{ V}$ on $V_{DD}$ and $V_{SS}$ $R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 1\text{ MHz}$ Refer to <a href="#">ACPSRR</a>	25°C		-70		dB
THD+N	Total Harmonic Distortion + Noise	$V_{\text{PP}} = 6\text{ V}$ , $V_{\text{BIAS}} = 6\text{ V}$ $R_L = 10\text{ k}\Omega$ , $C_L = 5\text{ pF}$ , $f = 20\text{ Hz}$ to $20\text{ kHz}$ Refer to <a href="#">THD + Noise</a>	25°C		0.001		%
$C_{\text{S(OFF)}}$	Source off capacitance	$V_S = 6\text{ V}$ , $f = 1\text{ MHz}$	25°C		52		pF
$C_{\text{D(OFF)}}$	Drain off capacitance	$V_S = 6\text{ V}$ , $f = 1\text{ MHz}$	25°C		68		pF
$C_{\text{S(ON)}}$ , $C_{\text{D(ON)}}$	On capacitance	$V_S = 6\text{ V}$ , $f = 1\text{ MHz}$	25°C		170		pF

## 6.14 Typical Characteristics

at  $T_A = 25^\circ\text{C}$  (unless otherwise noted)



### 6.14 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

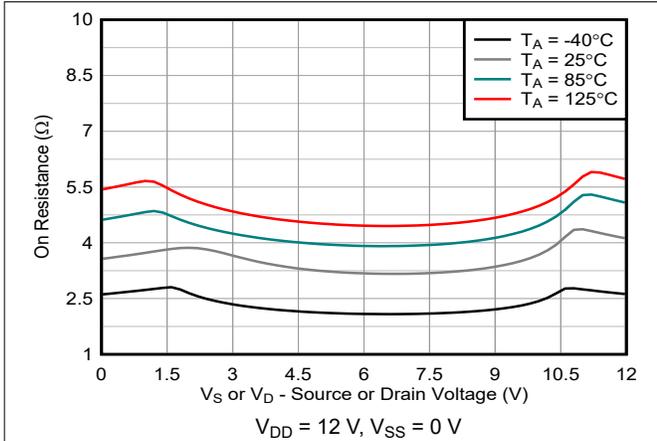


Figure 6-7. On-Resistance vs Temperature

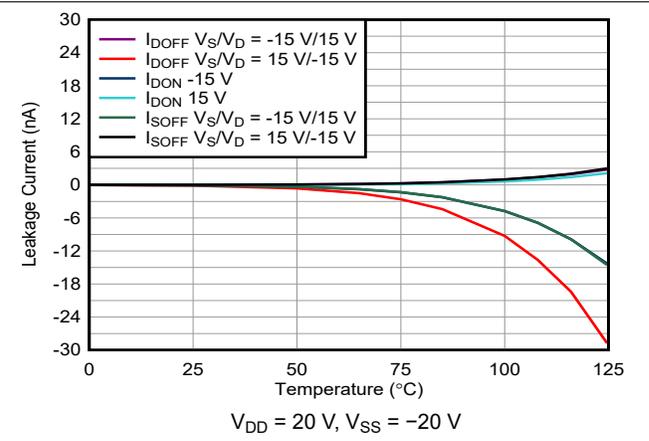


Figure 6-8. On-Leakage vs Temperature

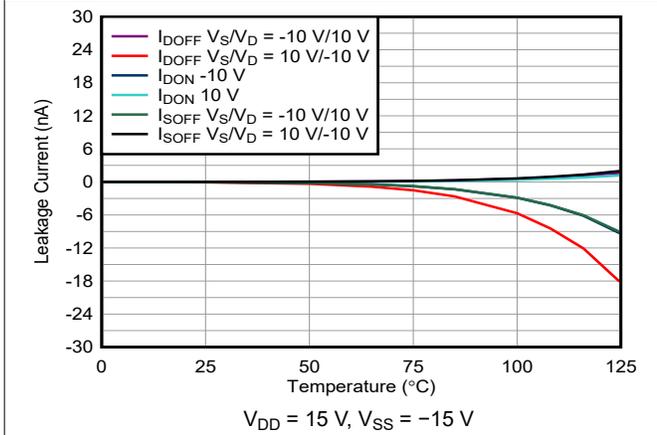


Figure 6-9. On-Leakage vs Temperature

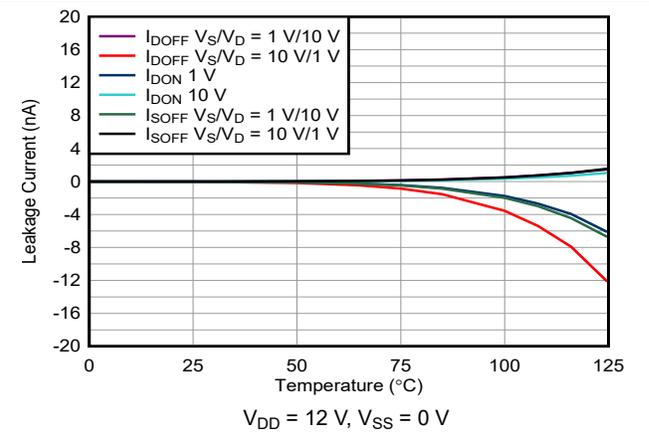


Figure 6-10. On-Leakage vs Temperature

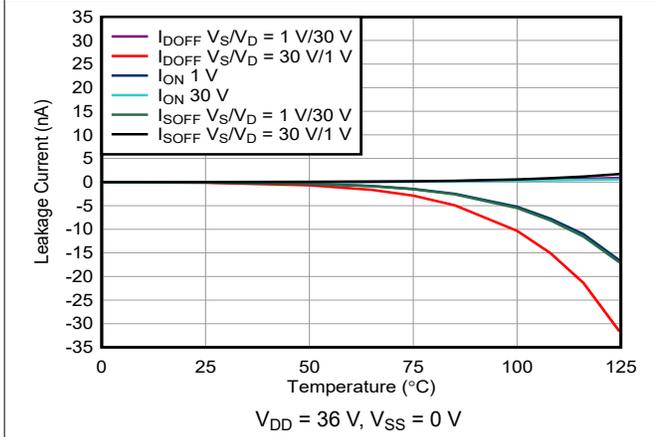


Figure 6-11. On-Leakage vs Temperature

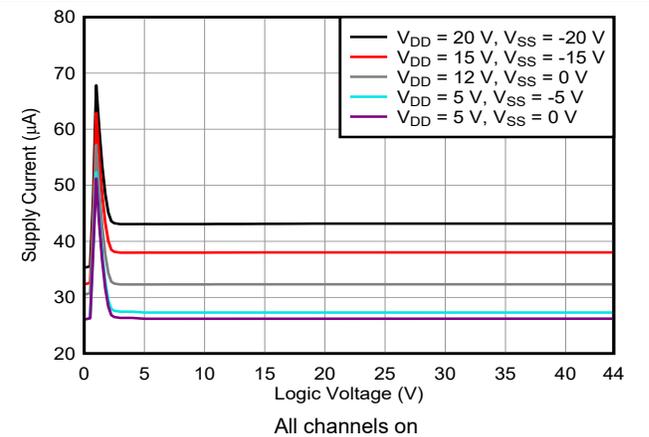


Figure 6-12. Supply Current vs Logic Voltage

### 6.14 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

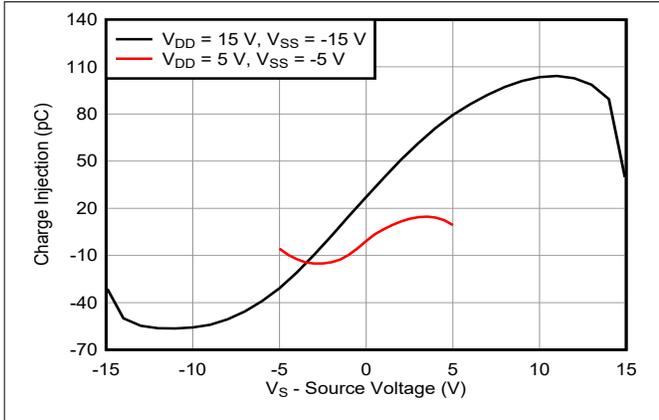


Figure 6-13. Charge Injection vs Source Voltage – Dual Supply

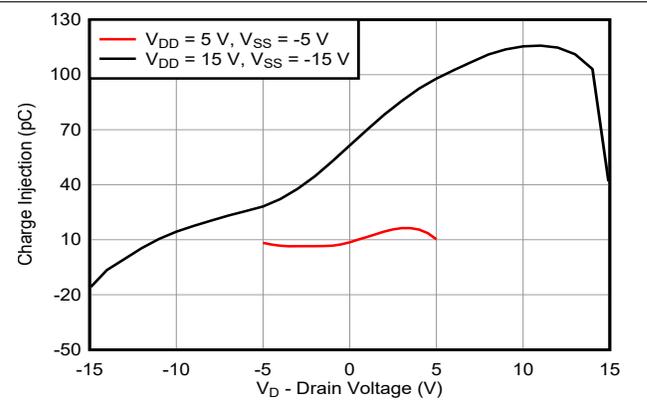


Figure 6-14. Charge Injection vs Drain Voltage – Dual Supply

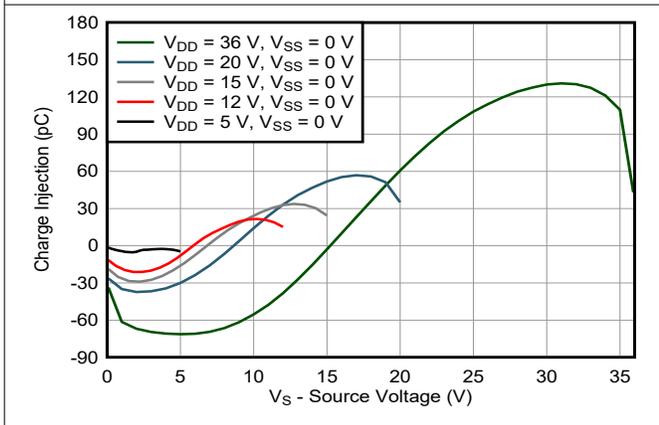


Figure 6-15. Charge Injection vs Source Voltage – Single Supply

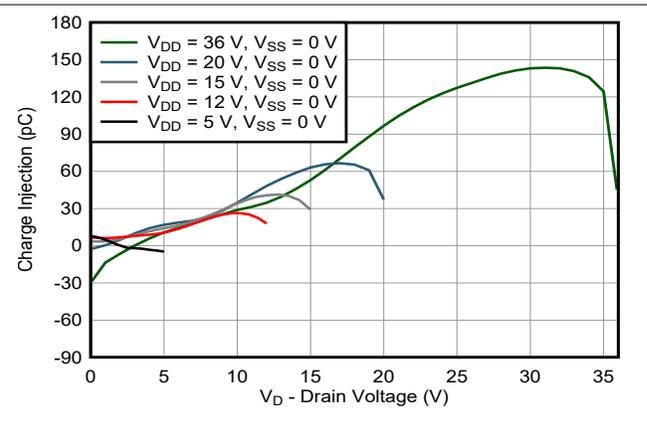


Figure 6-16. Charge Injection vs Drain Voltage – Single Supply

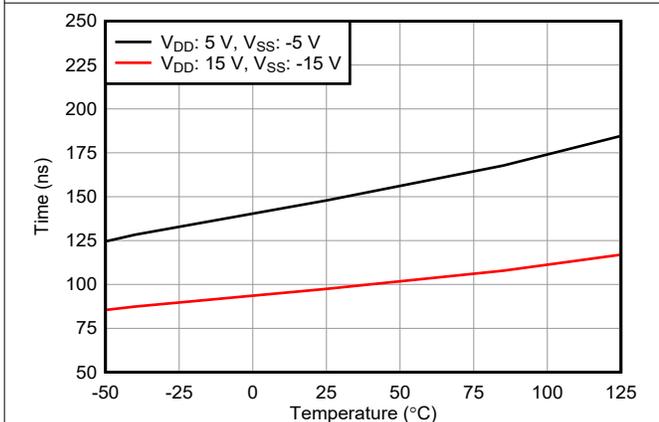


Figure 6-17.  $T_{\text{TRANSITION}}$  vs Temperature

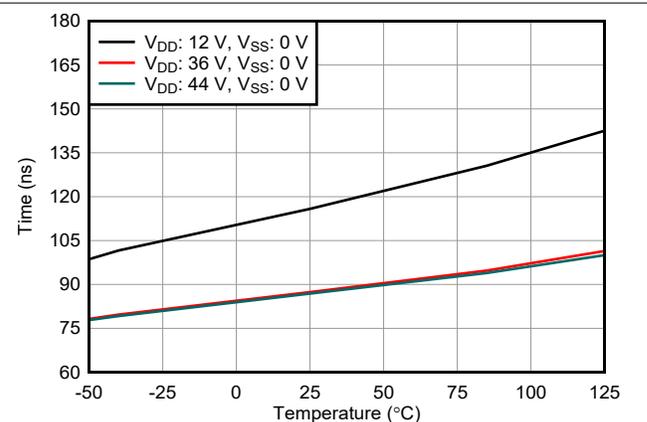
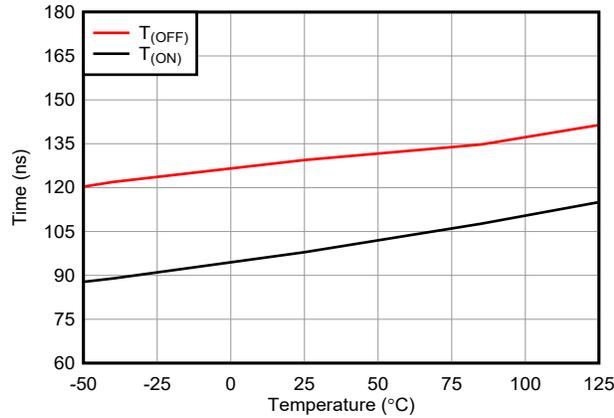


Figure 6-18.  $T_{\text{TRANSITION}}$  vs Temperature

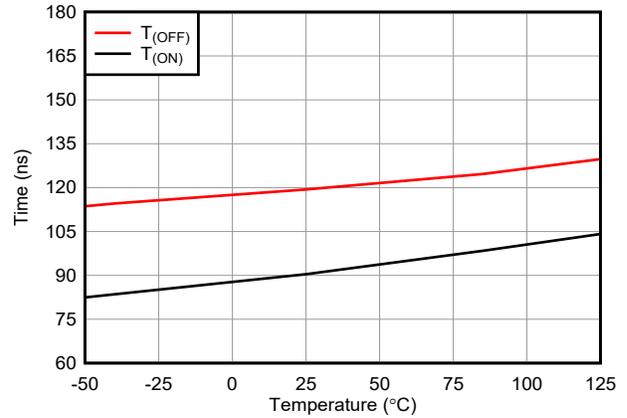
## 6.14 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$  (unless otherwise noted)



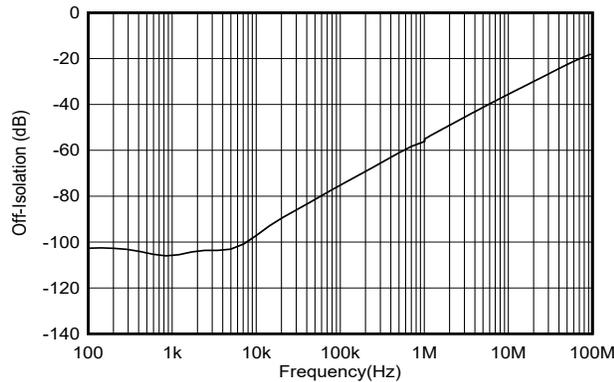
$V_{DD} = 15\text{ V}, V_{SS} = -15\text{ V}$

Figure 6-19.  $T_{ON(EN)}$  and  $T_{OFF(EN)}$  vs Temperature



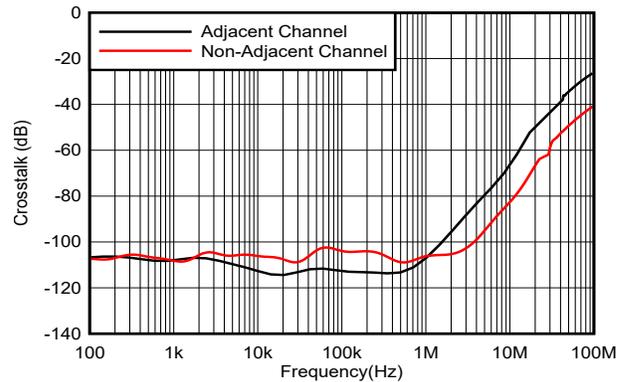
$V_{DD} = 44\text{ V}, V_{SS} = 0\text{ V}$

Figure 6-20.  $T_{ON(EN)}$  and  $T_{OFF(EN)}$  vs Temperature



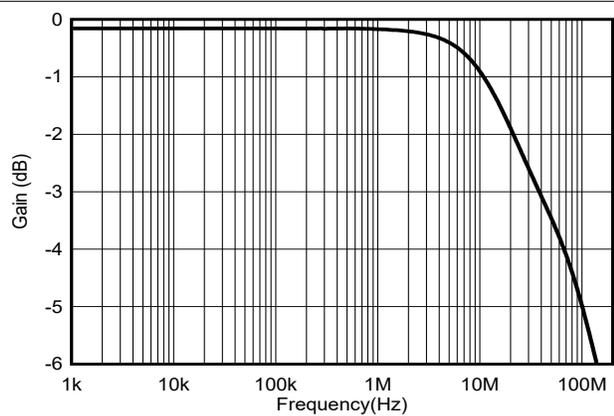
$V_{DD} = 15\text{ V}, V_{SS} = -15\text{ V}$

Figure 6-21. Off-Isolation vs Frequency



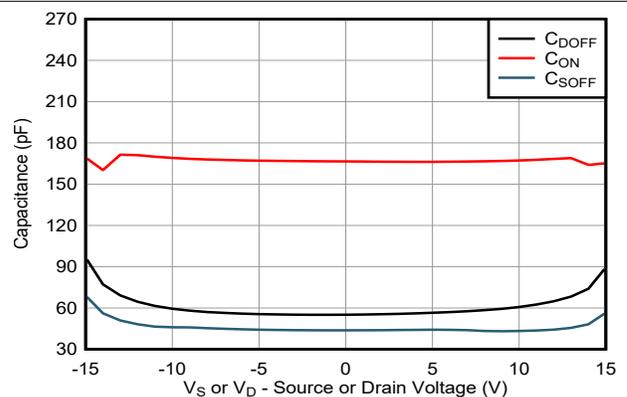
$V_{DD} = 15\text{ V}, V_{SS} = -15\text{ V}$

Figure 6-22. Crosstalk vs Frequency



$V_{DD} = 15\text{ V}, V_{SS} = -15\text{ V}$

Figure 6-23. On Response vs Frequency



$V_{DD} = 15\text{ V}, V_{SS} = -15\text{ V}$

Figure 6-24. Capacitance vs Source or Drain Voltage

### 6.14 Typical Characteristics (continued)

at  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

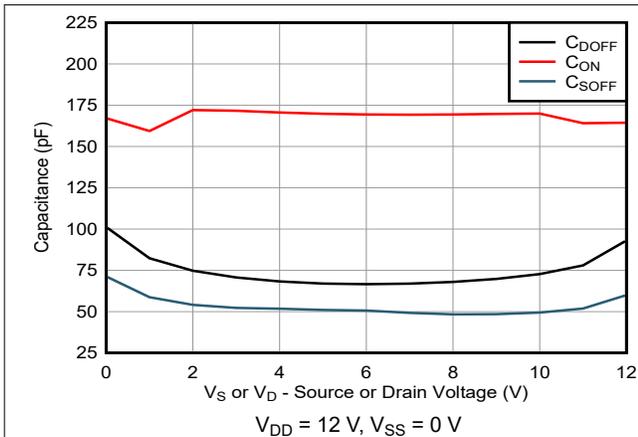


Figure 6-25. Capacitance vs Source or Drain Voltage

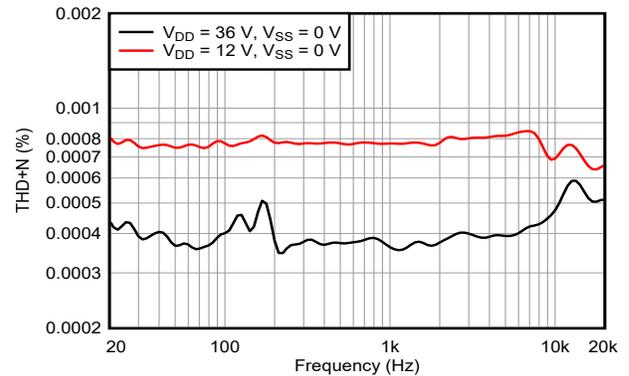


Figure 6-26. THD+N vs Frequency – Single Supply

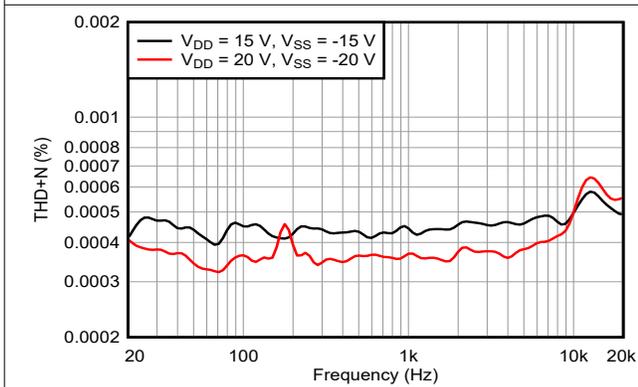


Figure 6-27. THD+N vs Frequency – Dual Supply

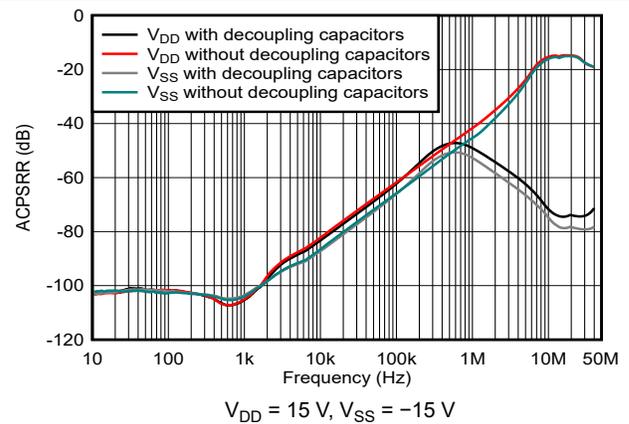


Figure 6-28. ACPSRR vs Frequency

## 7 Parameter Measurement Information

### 7.1 On-Resistance

The on-resistance of a device is the ohmic resistance between the source (Sx) and drain (D) pins of the device. The on-resistance varies with input voltage and supply voltage. The symbol  $R_{ON}$  is used to denote on-resistance. Figure 7-1 shows the measurement setup used to measure  $R_{ON}$ . Voltage (V) and current ( $I_{SD}$ ) are measured using this setup, and  $R_{ON}$  is computed with  $R_{ON} = V / I_{SD}$ .

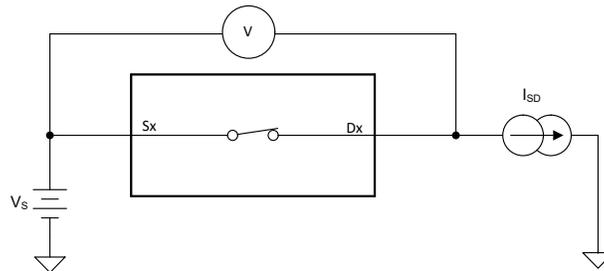


Figure 7-1. On-Resistance Measurement Setup

### 7.2 Off-Leakage Current

There are two types of leakage currents associated with a switch during the off state:

- Source off-leakage current
- Drain off-leakage current

Source leakage current is defined as the leakage current flowing into or out of the source pin when the switch is off. This current is denoted by the symbol  $I_{S(OFF)}$ .

Drain leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is off. This current is denoted by the symbol  $I_{D(OFF)}$ .

Figure 7-2 shows the setup used to measure both off-leakage currents.

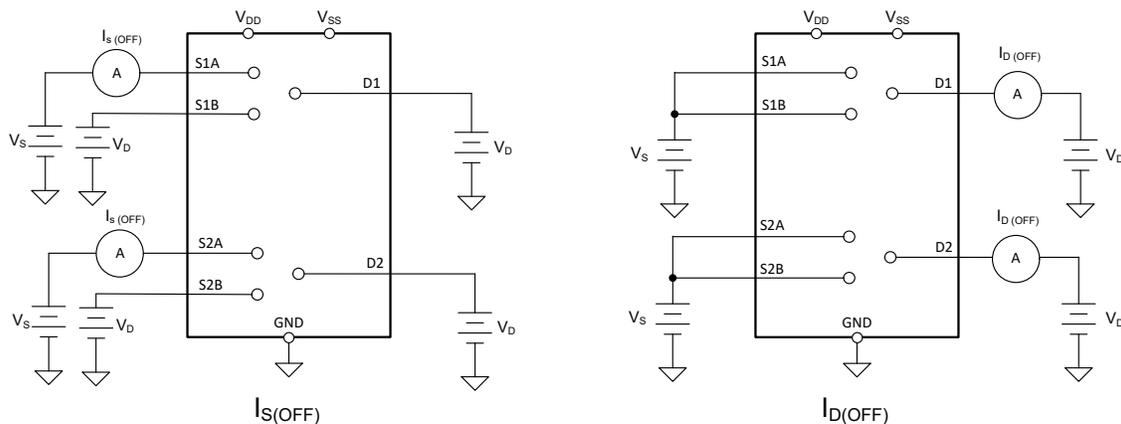


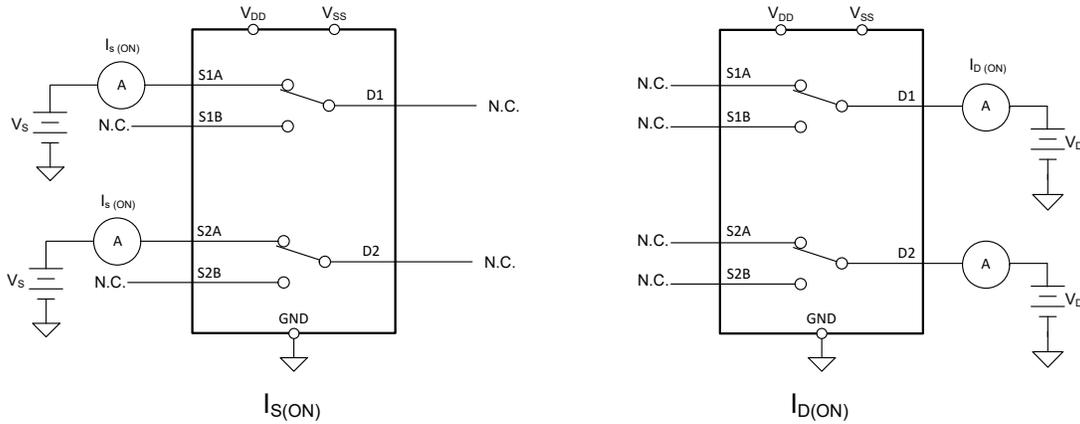
Figure 7-2. Off-Leakage Measurement Setup

### 7.3 On-Leakage Current

Source on-leakage current is defined as the leakage current flowing into or out of the source pin when the switch is on. This current is denoted by the symbol  $I_{S(ON)}$ .

Drain on-leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is on. This current is denoted by the symbol  $I_{D(ON)}$ .

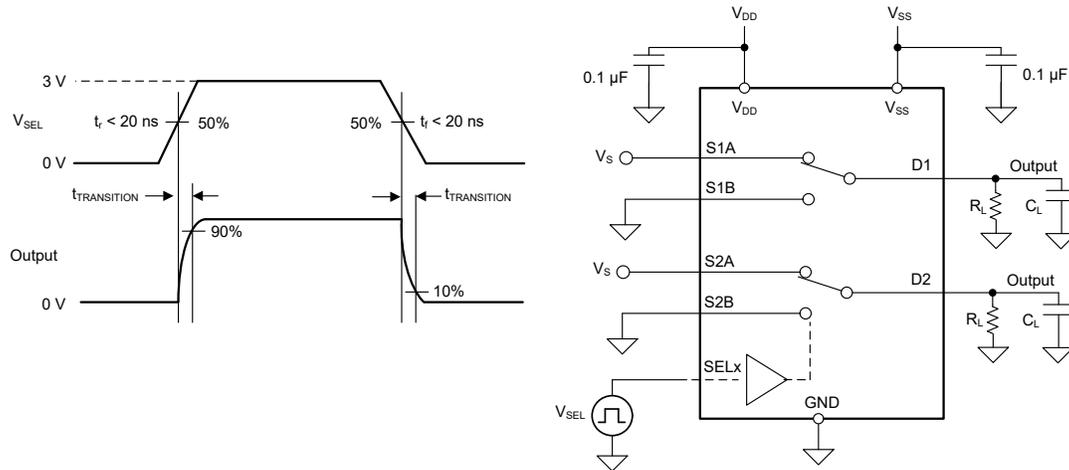
Either the source pin or drain pin is left floating during the measurement. [Figure 7-3](#) shows the circuit used for measuring the on-leakage current, denoted by  $I_{S(ON)}$  or  $I_{D(ON)}$ .



**Figure 7-3. On-Leakage Measurement Setup**

### 7.4 Transition Time

Transition time is defined as the time taken by the output of the device to rise or fall 90% after the address signal has risen or fallen past the logic threshold. The 90% transition measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. [Figure 7-4](#) shows the setup used to measure transition time, denoted by the symbol  $t_{TRANSITION}$ .



**Figure 7-4. Transition-Time Measurement Setup**

### 7.5 $t_{ON(EN)}$ and $t_{OFF(EN)}$

Turn-on time is defined as the time taken by the output of the device to rise to 90% after the enable has risen past the logic threshold. The 90% measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. Figure 7-7 shows the setup used to measure turn-on time, denoted by the symbol  $t_{ON(EN)}$ .

Turn-off time is defined as the time taken by the output of the device to fall to 10% after the enable has fallen past the logic threshold. The 10% measurement is utilized to provide the timing of the device. System level timing can then account for the time constant added from the load resistance and load capacitance. Figure 7-7 shows the setup used to measure turn-off time, denoted by the symbol  $t_{OFF(EN)}$ .

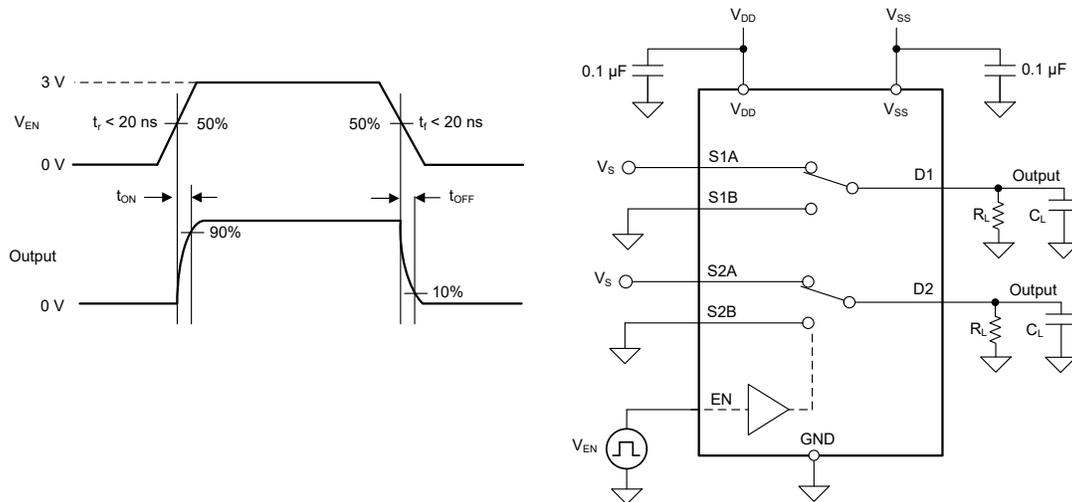


Figure 7-5. Turn-On and Turn-Off Time Measurement Setup

### 7.6 Break-Before-Make

Break-before-make delay is a safety feature that prevents two inputs from connecting when the device is switching. The output first breaks from the on-state switch before making the connection with the next on-state switch. The time delay between the *break* and the *make* is known as break-before-make delay. Figure 7-6 shows the setup used to measure break-before-make delay, denoted by the symbol  $t_{OPEN(BBM)}$ .

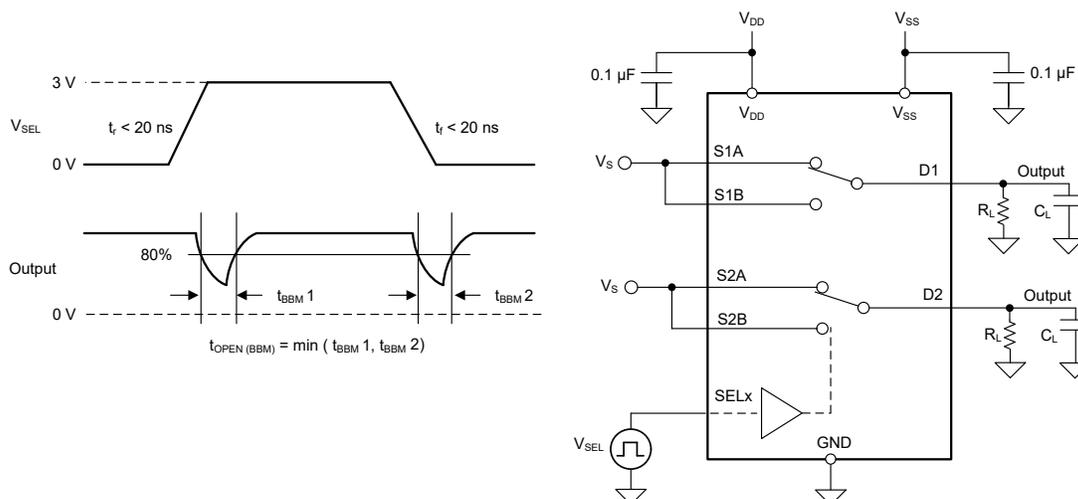


Figure 7-6. Break-Before-Make Delay Measurement Setup

### 7.7 $t_{ON(VDD)}$ Time

The  $t_{ON(VDD)}$  time is defined as the time taken by the output of the device to rise to 90% after the supply has risen past the supply threshold. The 90% measurement is used to provide the timing of the device turning on in the system. Figure 7-7 shows the setup used to measure turn on time, denoted by the symbol  $t_{ON(VDD)}$ .

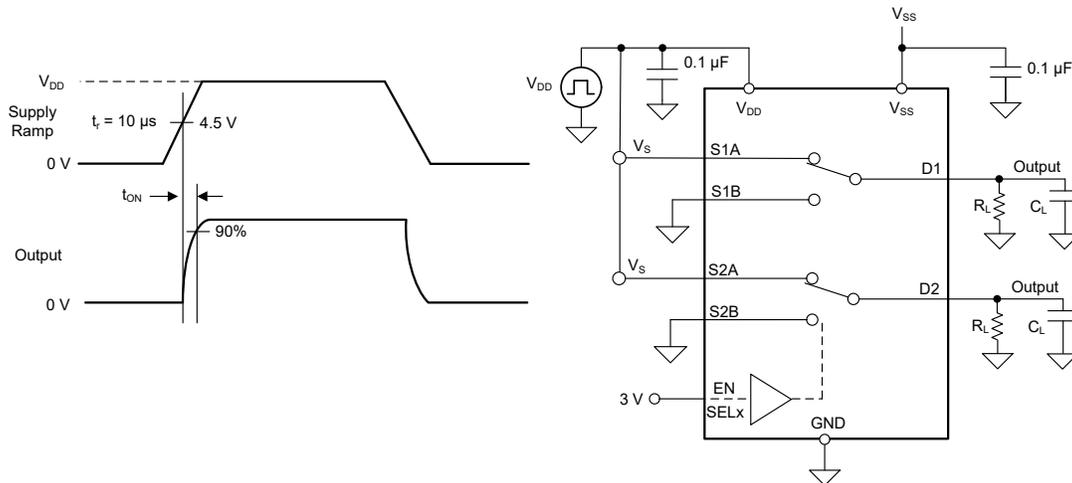


Figure 7-7.  $t_{ON(VDD)}$  Time Measurement Setup

### 7.8 Propagation Delay

Propagation delay is defined as the time taken by the output of the device to rise or fall 50% after the input signal has risen or fallen past the 50% threshold. Figure 7-8 shows the setup used to measure propagation delay, denoted by the symbol  $t_{PD}$ .

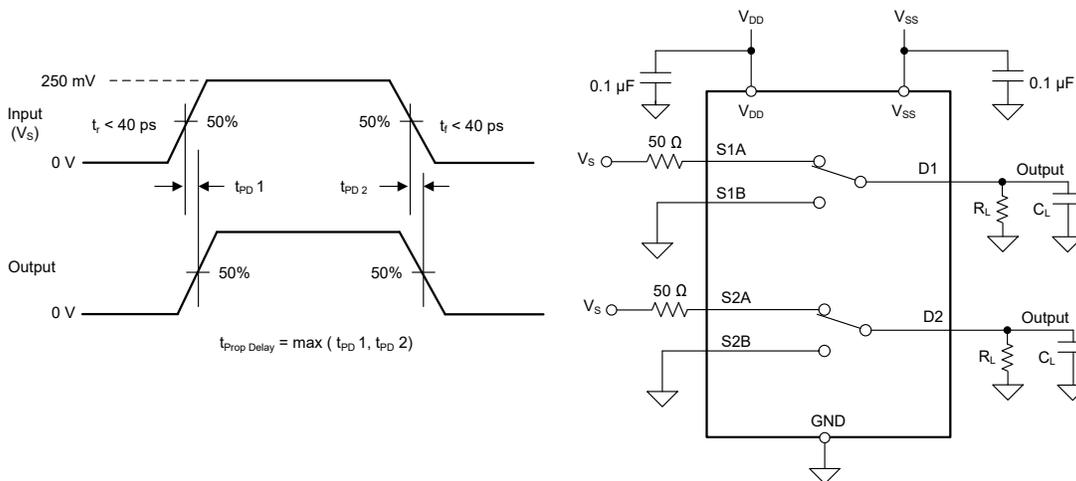


Figure 7-8. Propagation Delay Measurement Setup

## 7.9 Charge Injection

The TMUX7236 has a transmission-gate topology. Any mismatch in capacitance between the NMOS and PMOS transistors results in a charge injected into the drain or source during the falling or rising edge of the gate signal. The amount of charge injected into the source or drain of the device is known as charge injection, and is denoted by the symbol  $Q_{INJ}$ . Figure 7-9 shows the setup used to measure charge injection from source (Sx) to drain (D).

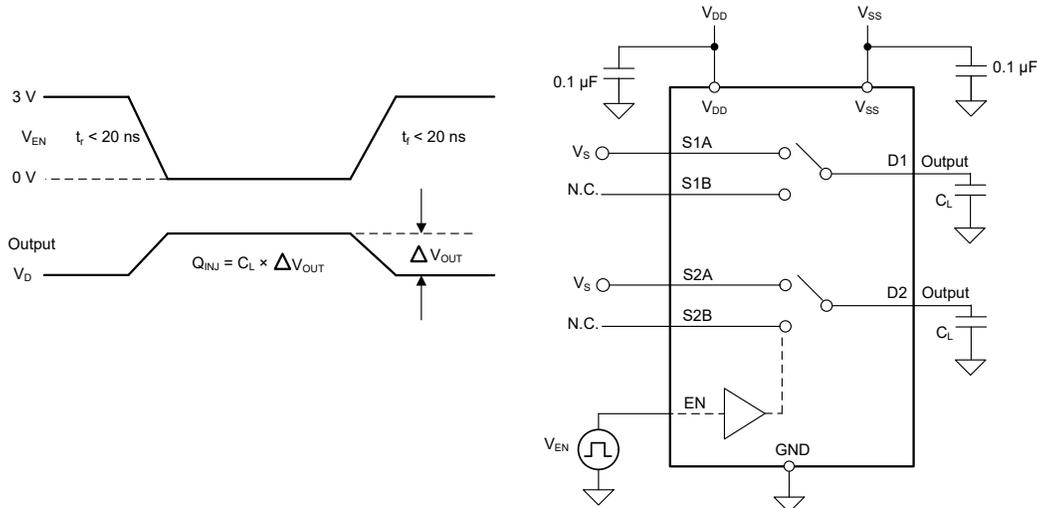


Figure 7-9. Charge-Injection Measurement Setup

## 7.10 Off Isolation

Off isolation is defined as the ratio of the signal at the drain pin (D) of the device when a signal is applied to the source pin (Sx) of an off-channel. Figure 7-10 shows the setup used to measure, and the equation used to calculate off isolation.

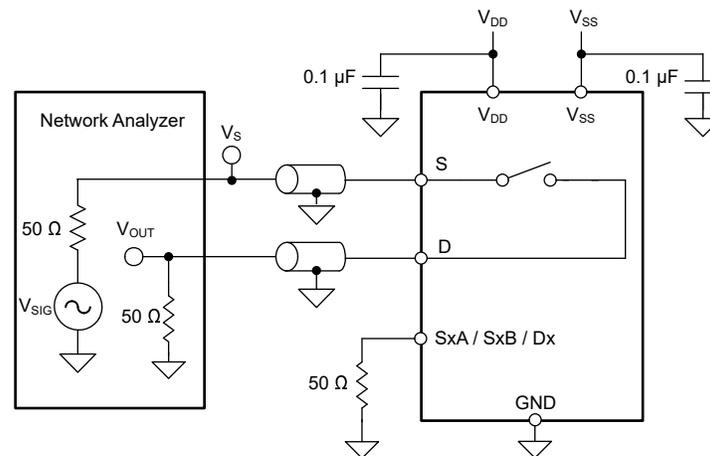
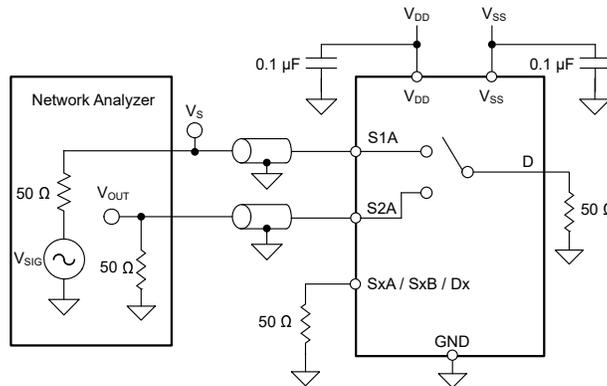


Figure 7-10. Off Isolation Measurement Setup

### 7.11 Crosstalk

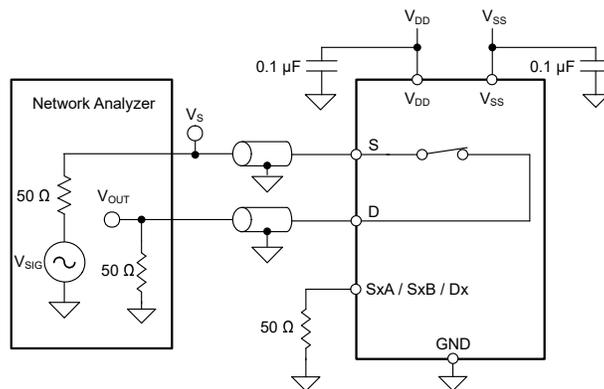
Crosstalk is defined as the ratio of the signal at the drain pin (D) of a different channel, when a signal is applied at the source pin (Sx) of an on-channel. [Figure 7-11](#) shows the setup used to measure and the equation used to calculate crosstalk.



**Figure 7-11. Crosstalk Measurement Setup**

### 7.12 Bandwidth

Bandwidth is defined as the range of frequencies that are attenuated by less than 3 dB when the input is applied to the source pin (Sx) of an on-channel, and the output is measured at the drain pin (D) of the device. [Figure 7-12](#) shows the setup used to measure bandwidth.



**Figure 7-12. Bandwidth Measurement Setup**

### 7.13 THD + Noise

The total harmonic distortion (THD) of a signal is a measurement of the harmonic distortion, and is defined as the ratio of the sum of the powers of all harmonic components to the power of the fundamental frequency at the mux output. The on-resistance of the device varies with the amplitude of the input signal and results in distortion when the drain pin is connected to a low-impedance load. Total harmonic distortion plus noise is denoted as THD.

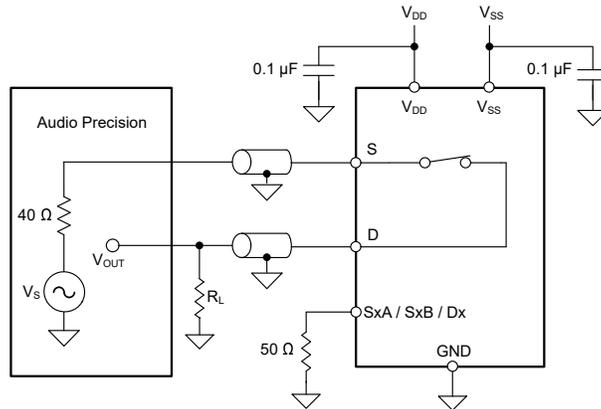


Figure 7-13. THD Measurement Setup

### 7.14 Power Supply Rejection Ratio (PSRR)

PSRR measures the ability of a device to prevent noise and spurious signals that appear on the supply voltage pin from coupling to the output of the switch. The DC voltage on the device supply is modulated by a sine wave of 620 mVPP. The ratio of the amplitude of signal on the output to the amplitude of the modulated signal is the ACPSRR. A high ratio represents a high degree of tolerance to supply rail variation.

Figure 7-14 shows how the decoupling capacitors reduce high frequency noise on the supply pins. This helps stabilize the supply and immediately filter as much of the supply noise as possible.

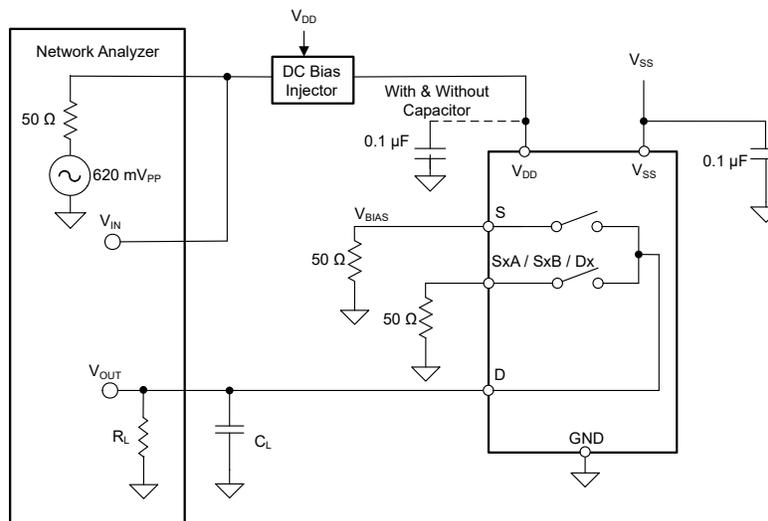
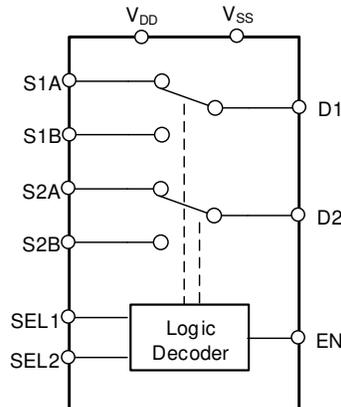


Figure 7-14. ACPSRR Measurement Setup

## 8 Detailed Description

### 8.1 Functional Block Diagram

The TMUX7236 is a 2:1, 2-channel multiplexer or demultiplexer. Each input is turned on or turned off based on the state of the select lines and enable pin.



### 8.2 Feature Description

#### 8.2.1 Bidirectional Operation

The TMUX7236 conducts equally well from source ( $S_x$ ) to drain ( $D_x$ ) or from drain ( $D_x$ ) to source ( $S_x$ ). Each channel has very similar characteristics in both directions and supports both analog and digital signals.

#### 8.2.2 Rail to Rail Operation

The valid signal path input or output voltage for TMUX7236 ranges from  $V_{SS}$  to  $V_{DD}$ .

#### 8.2.3 1.8 V Logic Compatible Inputs

The TMUX7236 has 1.8-V logic compatible control for all logic control inputs. 1.8-V logic level inputs allows the TMUX7236 to interface with processors that have lower logic I/O rails and eliminates the need for an external translator, which saves both space and bill of materials (BOM) cost. For more information on 1.8 V logic implementations, refer to [Simplifying Design with 1.8 V logic Muxes and Switches](#).

#### 8.2.4 Integrated Pull-Down Resistor on Logic Pins

The TMUX7236 has internal weak pull-down resistors to GND to ensure the logic pins are not left floating. The value of this pull-down resistor is approximately 4 M $\Omega$ , but is clamped to about 1  $\mu$ A at higher voltages. This feature integrates up to three external components and reduces system size and cost.

#### 8.2.5 Fail-Safe Logic

The TMUX7236 supports Fail-Safe Logic on the control input pins (EN and SEL) allowing the device to operate up to 44 V above  $V_{SS}$ , regardless of the state of the supply pins. This feature allows voltages on the control pins to be applied before the supply pin, protecting the device from potential damage. Fail-Safe Logic minimizes system complexity by removing the need for power supply sequencing on the logic control pins. For example, the Fail-Safe Logic feature allows the logic input pins of the TMUX7236 to be ramped to +44 V while  $V_{DD}$  and  $V_{SS} = 0$  V. The logic control inputs are protected against positive faults of up to +44 V in the powered-off condition, but does not offer protection against negative overvoltage conditions.

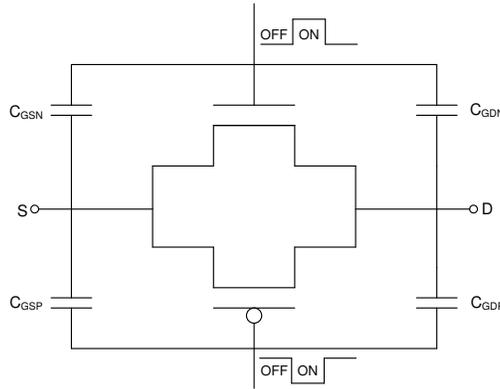
### 8.2.6 Latch-Up Immune

Latch-up is a condition where a low impedance path is created between a supply pin and ground. The latch-up condition is caused by a trigger (current injection or overvoltage); but once activated, the low impedance path remains even after the trigger is no longer present. This low impedance path may cause system upset or catastrophic damage due to excessive current levels. The latch-up condition typically requires a power cycle to eliminate the low impedance path.

The TMUX7236 is constructed on silicon on insulator (SOI) based process where an oxide layer is added between the PMOS and NMOS transistor of each CMOS switch to prevent parasitic structures from forming. The oxide layer is also known as an insulating trench and prevents triggering of latch up events due to overvoltage or current injections. The latch-up immunity feature allows the TMUX7236 to be used in harsh environments. For more information on latch-up immunity, refer to [Using Latch Up Immune Multiplexers to Help Improve System Reliability](#).

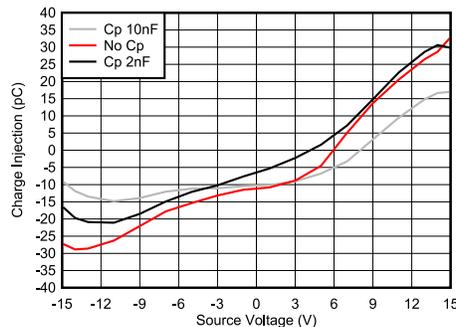
### 8.2.7 Ultra-Low Charge Injection

Figure 8-1 shows how the TMUX7236 device has a transmission gate topology. Any mismatch in the stray capacitance associated with the NMOS and PMOS causes an output level change whenever the switch is opened or closed.



**Figure 8-1. Transmission Gate Topology**

The TMUX7236 contains specialized architecture to reduce charge injection on the Drain (Dx). To further reduce charge injection in a sensitive application, a compensation capacitor (Cp) can be added on the Source (Sx). This will ensure that excess charge from the switch transition is pushed into the compensation capacitor on the Source (Sx) instead of the Drain (Dx). As a general rule, Cp should be 20x larger than the equivalent load capacitance on the Drain (Dx). Figure 8-2 shows charge injection variation with different compensation capacitors on the Source side. Figure 8-2 was captured on the TMUX7219 as part of the TMUX72xx family with a 100 pF load capacitance.



**Figure 8-2. Charge Injection Compensation**

### 8.3 Device Functional Modes

When the EN pin of the TMUX7236 is pulled high, one of the switches is closed based on the state of the SEL pin. When the EN pin is pulled low, both of the switches are in an open state regardless of the state of the SEL pin. The control pins can be as high as 44 V.

### 8.4 Truth Tables

Table 8-1 show the truth tables for the TMUX7236.

**Table 8-1. TMUX7236 Truth Table**

EN	SELx	Selected Input Connected To Drain (D) Pin
0	X <sup>(1)</sup>	All channels are off (Hi-Z)
1	0	SxB
1	1	SxA

(1) X denotes *do not care*.

## 9 Application and Implementation

### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

The TMUX7236 is part of the precision switches and multiplexers family of devices. This device operates with dual supplies ( $\pm 4.5$  V to  $\pm 22$  V), a single supply (4.5 V and 44 V), or asymmetric supplies (such as,  $V_{DD} = 12$  V and  $V_{SS} = -5$  V), and offers rail-to-rail input and output. The TMUX7236 offers low  $R_{ON}$ , low on and off leakage currents and ultra-low charge injection performance. These features makes the TMUX7236 a precision, robust, high-performance analog multiplexer for high-voltage, industrial applications.

### 9.2 Typical Application

One application for the TMUX7236 is in data acquisition systems. For these types of input modules, accuracy and precision is key. To help account for drift over time and temperature, a calibration path is often added to calibrate the input in real time before a measurement. An SPDT switch can be used to switch in this calibration path, which the TMUX7236 is ideal for. This device offers a very low on-resistance, leakage, and charge injection, which ensures a high measurement fidelity and reduces error. The break-before-make feature allows switching from the calibration path without shorting the inputs together. This device also offers on-resistance mismatch, which makes this device suitable for high precision systems. As [Figure 9-1](#) shows, the TMUX7236 can be used in both voltage and current acquisition.

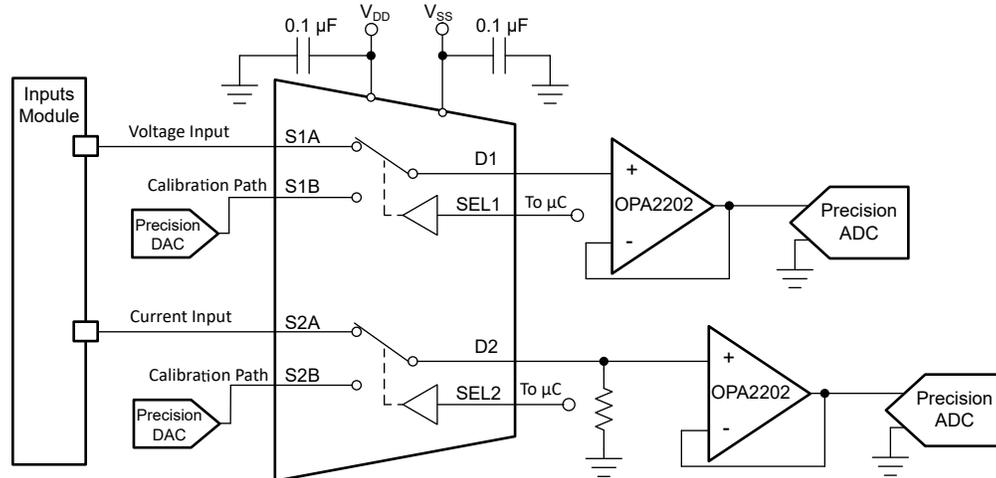


Figure 9-1. Data Acquisition Systems (DAQ) Calibration

### 9.2.1 Design Requirements

For this design example, use the parameters listed in Table 9-1.

Table 9-1. Design Parameters

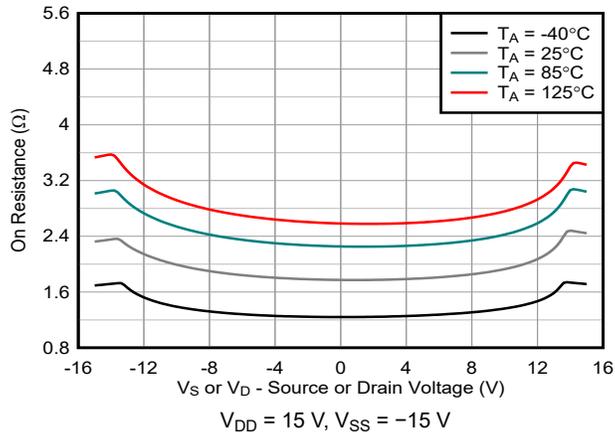
PARAMETERS	VALUES
Supply ( $V_{DD}$ )	15 V
Supply ( $V_{SS}$ )	-15 V
MUX I/O signal range	-15 V to 15 V (Rail-to-Rail)
Control logic thresholds	1.8 V compatible (up to $V_{DD}$ )
EN	EN pulled high to enable the switch

### 9.2.2 Detailed Design Procedure

The TMUX7236 can operate without any external components except for the supply decoupling capacitors. All inputs passing through the switch must fall within the recommended operating conditions of the TMUX7236, including signal range and continuous current. The signal range for this design can be up to -15 V to +15 V and the maximum continuous current can be up to 330 mA for wide-range current measurement with a positive supply of 15 V on  $V_{DD}$  and negative supply of -15 V on  $V_{SS}$  (for more information, see Section 6.4). The TMUX7236 device is a bidirectional, single-pole double-throw (SPDT) switch that offers low on-resistance, low leakage, and low power. These features make this device suitable for precision and power sensitive applications.

### 9.2.3 Application Curve

The low on-resistance of TMUX7236 and ultra-low charge injection performance make this device ideal for implementing high precision systems. Figure 9-2 shows the plot for the on-resistance versus temperature. Additionally, the TMUX7236 features a very low mismatch between channels, which is important for this application because it reduces the difference between the calibration and non-calibration paths. The TMUX7236 features mismatch between channels <180 mΩ and 100 mΩ typically.



**Figure 9-2. On-Resistance vs Temperature**

**9.2.3.1 On-Resistance Mismatch Between Channels**

$V_{DD} = +15\text{ V} \pm 10\%$ ,  $V_{SS} = -15\text{ V} \pm 10\%$ , GND = 0 V (unless otherwise noted)

Typical at  $V_{DD} = +15\text{ V}$ ,  $V_{SS} = -15\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS	$T_A$	MIN	TYP	MAX	UNIT
$\Delta R_{ON}$	On-resistance mismatch between channels	$V_S = -10\text{ V to } +10\text{ V}$ $I_D = -10\text{ mA}$ Refer to <a href="#">On-Resistance</a>	25°C		0.1	0.18	$\Omega$
			-40°C to +85°C			0.19	$\Omega$
			-40°C to +125°C			0.21	$\Omega$

**10 Power Supply Recommendations**

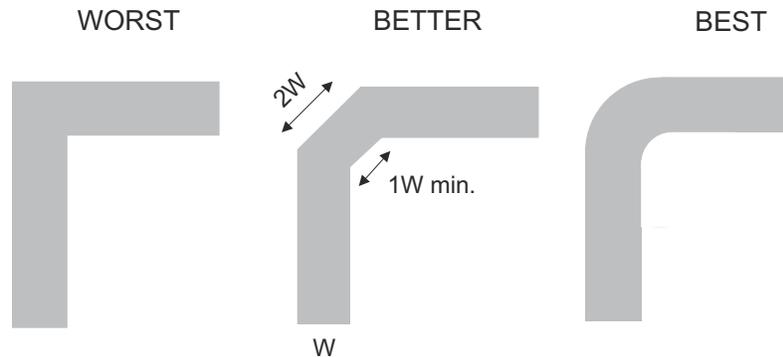
The TMUX7236 operates across a wide supply range of of  $\pm 4.5\text{ V to } \pm 22\text{ V}$  (4.5 V to 44 V in single-supply mode). The device also performs well with asymmetrical supplies such as  $V_{DD} = 12\text{ V}$  and  $V_{SS} = -5\text{ V}$ .

Power-supply bypassing improves noise margin and prevents switching noise propagation from the supply rails to other components. Good power-supply decoupling is important to achieve optimum performance. For improved supply noise immunity, use a supply decoupling capacitor ranging from 0.1  $\mu\text{F}$  to 10  $\mu\text{F}$  at both the  $V_{DD}$  and  $V_{SS}$  pins to ground. Place the bypass capacitors as close to the power supply pins of the device as possible using low-impedance connections. TI recommends using multi-layer ceramic chip capacitors (MLCCs) that offer low equivalent series resistance (ESR) and inductance (ESL) characteristics for power-supply decoupling purposes. For very sensitive systems, or for systems in harsh noise environments, avoiding the use of vias for connecting the capacitors to the device pins may offer superior noise immunity. The use of multiple vias in parallel lowers the overall inductance and is beneficial for connections to ground planes. Always ensure the ground (GND) connection is established before supplies are ramped.

## 11 Layout

### 11.1 Layout Guidelines

When a PCB trace turns a corner at a 90° angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self-inductance of the trace which results in the reflection. Not all PCB traces can be straight and therefore some traces must turn corners. [Figure 11-1](#) shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.



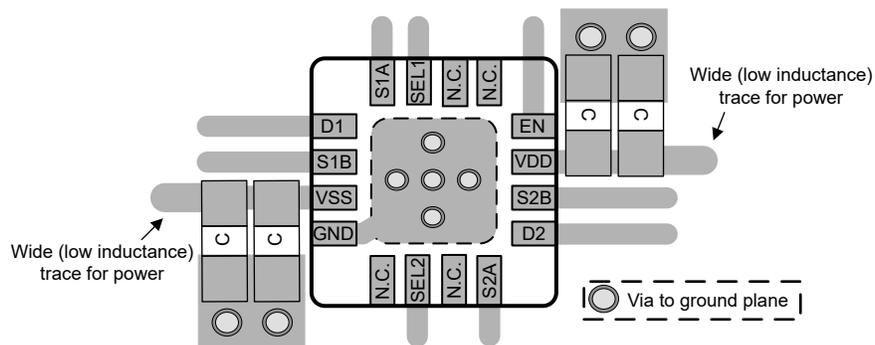
**Figure 11-1. Trace Example**

Route high-speed signals using a minimum of vias and corners which reduces signal reflections and impedance changes. When a via must be used, increase the clearance size around it to minimize its capacitance. Each via introduces discontinuities in the signal's transmission line and increases the chance of picking up interference from the other layers of the board. Be careful when designing test points, through-hole pins are not recommended at high frequencies.

Some key considerations are as follows:

- For reliable operation, connect a decoupling capacitor ranging from 0.1  $\mu\text{F}$  to 10  $\mu\text{F}$  between VDD/VSS and GND. TI recommends a 0.1- $\mu\text{F}$  and 1- $\mu\text{F}$  capacitor, placing the lowest value capacitor as close to the pin as possible. Make sure that the capacitor voltage rating is sufficient for the supply voltage.
- Keep the input lines as short as possible.
- Use a solid ground plane to help reduce electromagnetic interference (EMI) noise pickup.
- Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if possible, and only make perpendicular crossings when necessary.
- Using multiple vias in parallel will lower the overall inductance and is beneficial for connection to ground planes.

### 11.2 Layout Example



**Figure 11-2. TMUX7236 Layout Example**

## 12 Device and Documentation Support

### 12.1 Documentation Support

#### 12.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [Eliminate Power Sequencing with Powered-off Protection Signal Switches](#)
- Texas Instruments, [Improve Stability Issues with Low CON Multiplexers](#)
- Texas Instruments, [QFN/SON PCB Attachment](#)
- Texas Instruments, [Quad Flatpack No-Lead Logic Packages](#)
- Texas Instruments, [Simplifying Design with 1.8 V logic Muxes and Switches](#)
- Texas Instruments, [System-Level Protection for High-Voltage Analog Multiplexers](#)
- Texas Instruments, [True Differential, 4 x 2 MUX, Analog Front End, Simultaneous-Sampling ADC Circuit](#)

#### 12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](http://ti.com). Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 12.3 Support Resources

TI E2E™ [support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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#### 12.4 Trademarks

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#### 12.5 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

#### 12.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TMUX7236RUMR	ACTIVE	WQFN	RUM	16	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TMUX T236	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

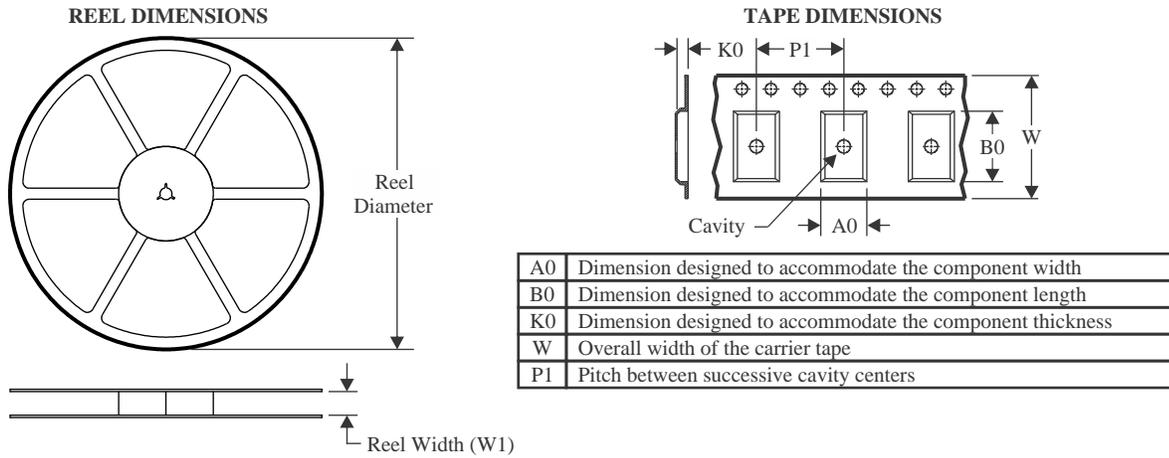
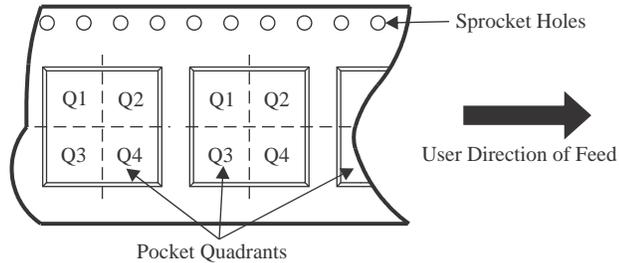
(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

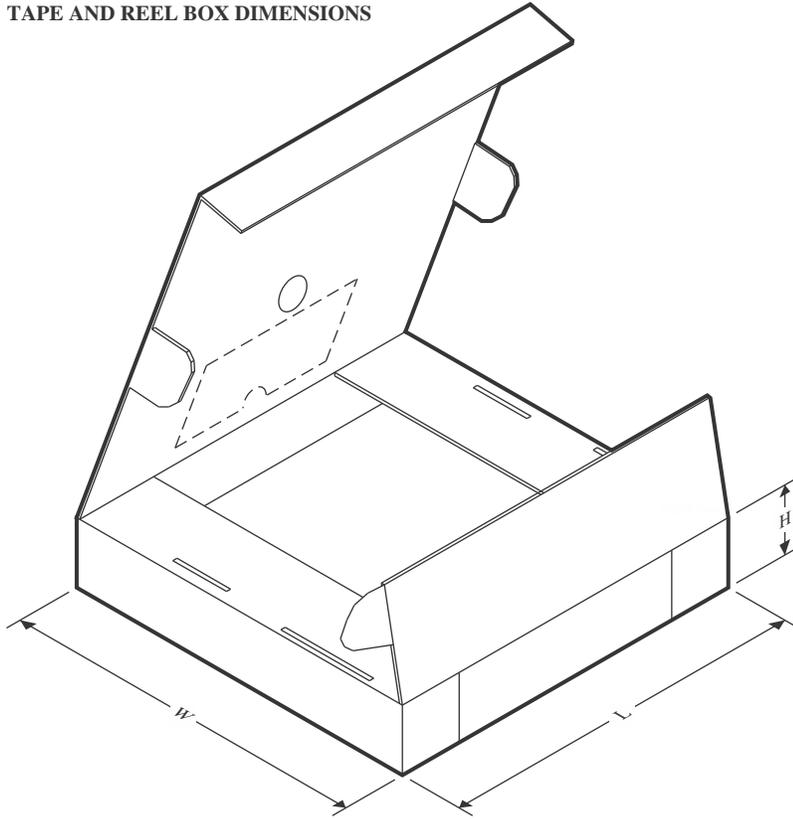
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**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TMUX7236RUMR	WQFN	RUM	16	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TMUX7236RUMR	WQFN	RUM	16	3000	367.0	367.0	35.0

## GENERIC PACKAGE VIEW

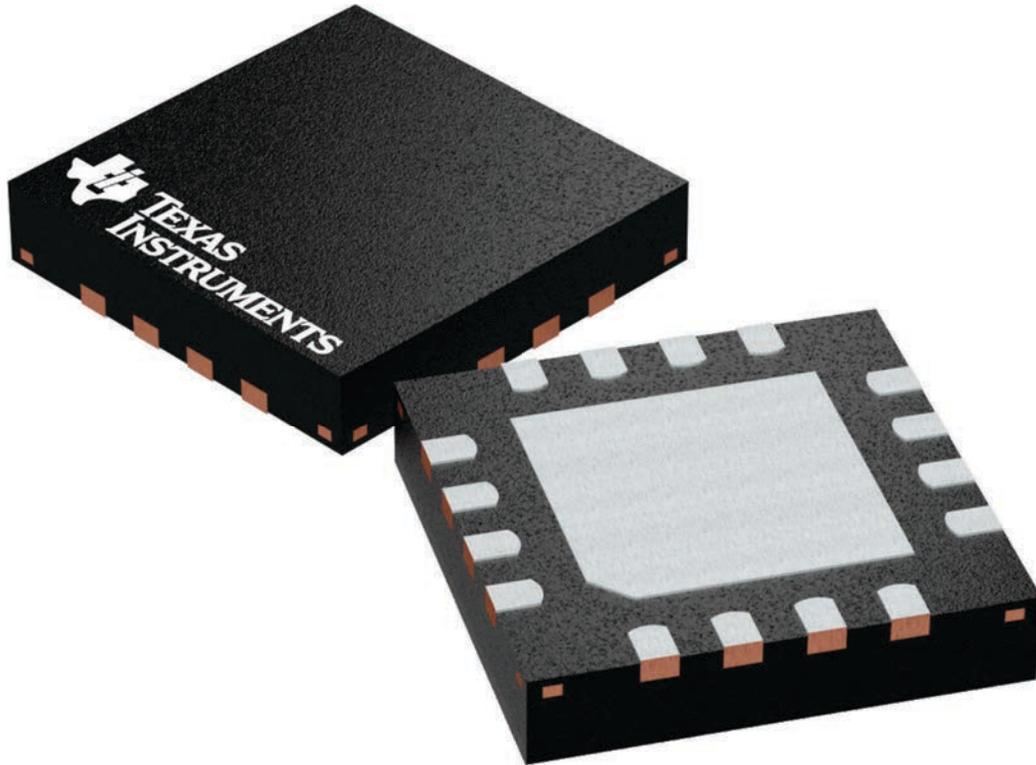
**RUM 16**

**WQFN - 0.8 mm max height**

4 x 4, 0.65 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.



4224843/A

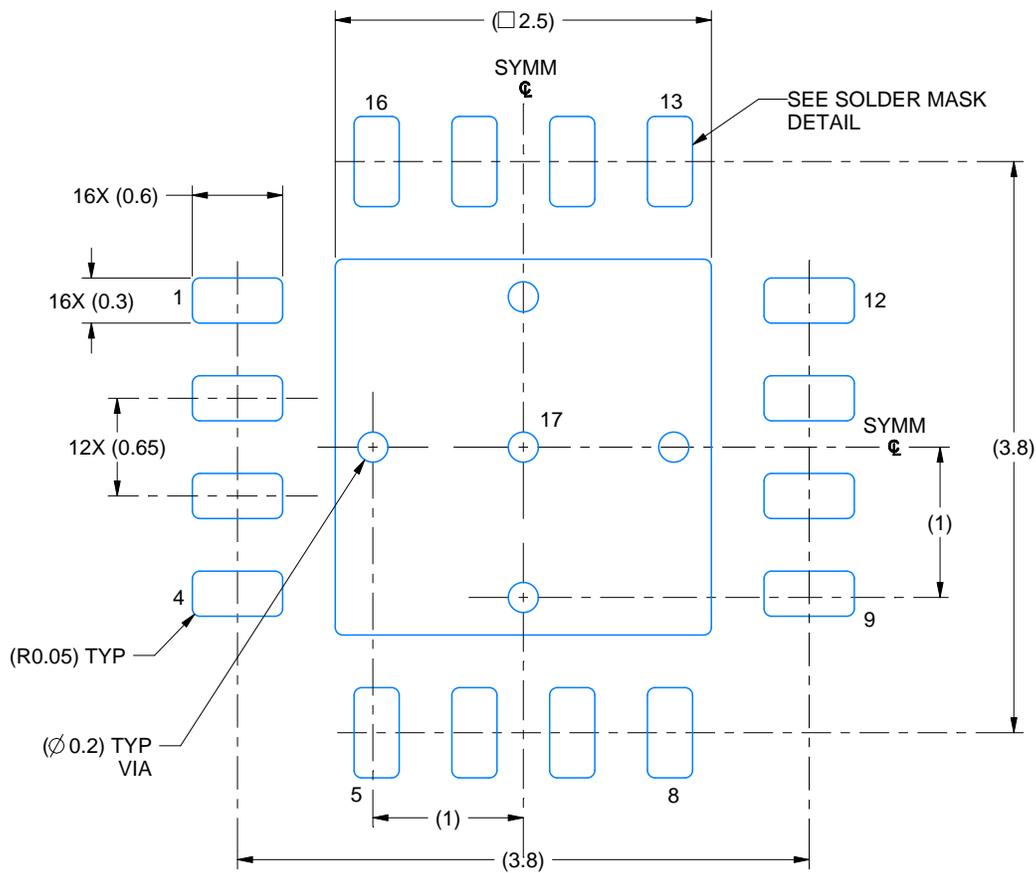


# EXAMPLE BOARD LAYOUT

RUM0016E

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 20X



4224815/A 02/2019

NOTES: (continued)

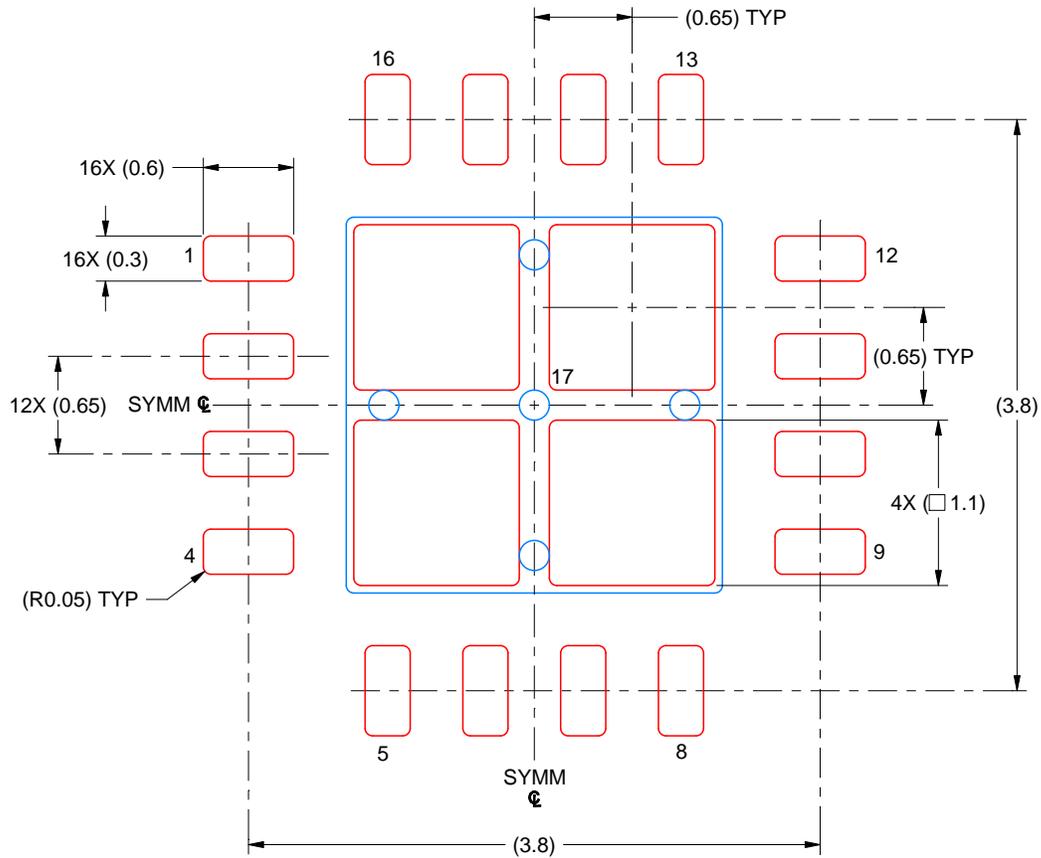
- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

# EXAMPLE STENCIL DESIGN

RUM0016E

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.125 MM THICK STENCIL  
SCALE: 20X

EXPOSED PAD 17  
77% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

4224815/A 02/2019

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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